

# TPS4335x-Q1 Low $I_Q$ , Dual Synchronous Buck Controller

## 1 Features

- Qualified for Automotive Applications
- AEC-Q100 Test Guidance With the Following Results:
  - Device Temperature Grade 1:  $-40^{\circ}\text{C}$  to  $125^{\circ}\text{C}$  Ambient Operating Temperature
  - Device HBM ESD Classification Level H2
  - Device HBM CDM Classification Level C2
- Two Synchronous Buck Controllers
- Input Range up to 40 V (Transients up to 60 V)
- Low-Power Mode  $I_Q$ : 30  $\mu\text{A}$  (One Buck On), 35  $\mu\text{A}$  (Two Bucks On)
- Low Shutdown Current  $I_{\text{sh}} < 4 \mu\text{A}$
- Buck Output Range 0.9 V to 11 V
- Programmable Frequency and External Synchronization Range 150 kHz to 600 kHz
- Separate Enable Inputs (ENA, ENB)
- Frequency Spread Spectrum (TPS43351-Q1)
- Selectable Forced Continuous Mode or Automatic Low-Power Mode at Light Loads
- Sense Resistor or Inductor DCR Sensing
- Out-of-Phase Switching Between Buck Channels
- Peak Gate Drive Current 1.5 A
- Thermally Enhanced, 38-Pin HTSSOP (DAP) PowerPAD™ Package

## 2 Applications

- Automotive Infotainment, Navigation, and Instrument Cluster Systems
- Industrial or Automotive Multi-Rail DC Power Distribution Systems and Electronic Control Units

## 3 Description

The TPS43350-Q1 and TPS43351-Q1 include two current-mode synchronous buck controllers designed for the harsh environment in automotive applications. The devices are ideal for use in a multi-rail system with low quiescent requirements, as they automatically operate in low-power mode (consuming typically 30  $\mu\text{A}$ ) at light loads. The devices offer protection features such as thermal, soft-start, and overcurrent protection. During short-circuit conditions of the regulator output, activation of the current-foldback feature can limit the current through the MOSFETs for control of power dissipation. The two independent soft-start inputs allow ramp-up of the output voltage independently during start-up.

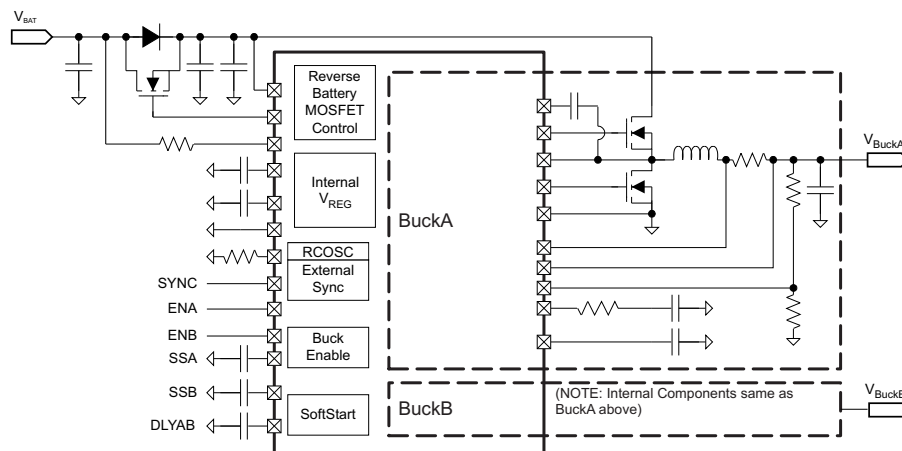
The programmable range of the switching frequency is from 150 kHz to 600 kHz, as is the frequency of an external clock to which the devices can synchronize. Additionally, the TPS43351-Q1 offers frequency-hopping spread-spectrum operation.

### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPS43350-Q1	HTSSOP (38)	12.50 mm x 6.20 mm
TPS43351-Q1		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

### Typical Application Diagram



Copyright © 2016, Texas Instruments Incorporated



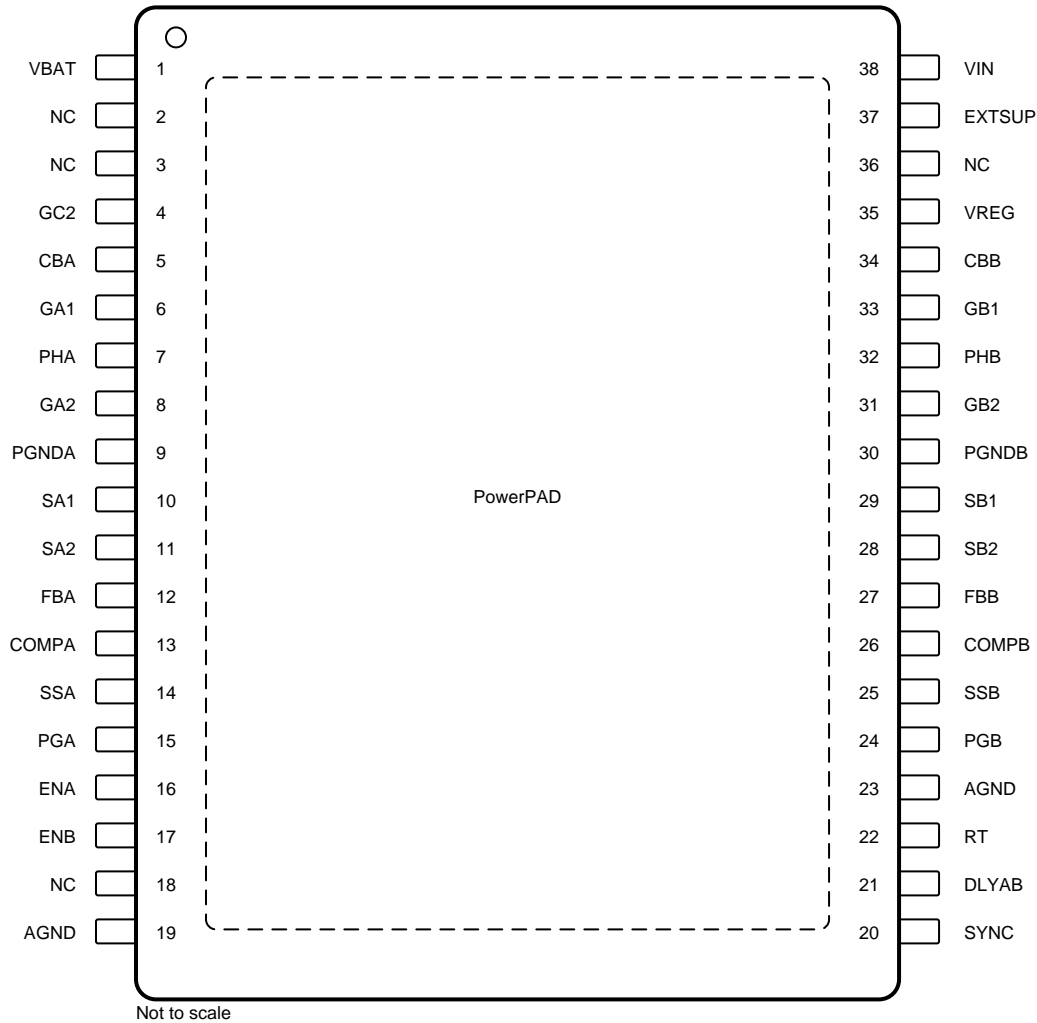


**Changes from Revision B (June 2011) to Revision C**
**Page**

• Changed input-voltage value for pins ENA and ENB .....	5
• Added a sentence to EXTSUP pin description .....	5
• Corrected AEC specification in ESD ratings .....	6
• Multiple changes throughout Electrical Characteristics table .....	7
• Changed upper threshold voltage for ENx pins to 1.7 V .....	14
• Text deletion from second paragraph of Light-Load PFM Mode section .....	16
• Changed value of gate-driver decoupling capacitor .....	17
• Added upper voltage limit for EXTSUP pin .....	17
• Replaced paragraphs following the figure at end of Gate-Driver Supply section.....	18
• Revised diagram of Simplified Application Schematic Example .....	19
• Clarified parameter definition in Application Example table .....	20
• Added equations for Output Capacitor $C_{OUTA}$ section .....	21
• Added equations for BuckB Component Selection section .....	23
• Changed peak output current in BuckX High-Side and Low-Side N-Channel MOSFETs section .....	24

## 5 Pin Configuration and Functions

**DAP Package**  
**38-Pin HTSSOP With PowerPAD**  
**Top View**



### Pin Functions

NAME	NO.	TYPE	DESCRIPTION
AGND	19, 23	GND	Analog ground reference
CBA	5	I	A capacitor on this pin acts as the voltage supply for the high-side N-channel MOSFET gate-drive circuitry in buck controller BuckA. When the buck is in a dropout condition, the device automatically reduces the duty cycle of the high-side MOSFET to approximately 95% on every fourth cycle to allow the capacitor to recharge.
CBB	34	I	A capacitor on this pin acts as the voltage supply for the high-side N-channel MOSFET gate-drive circuitry in buck controller BuckB. When the buck is in a dropout condition, the device automatically reduces the duty cycle of the high-side MOSFET to approximately 95% on every fourth cycle to allow the capacitor to recharge.
COMPA	13	O	Error amplifier output of BuckA and compensation node for voltage-loop stability. The voltage at this node sets the target for the peak current through the inductor of BuckA. Clamping this voltage on the upper and lower ends provides current-limit protection for the external MOSFETs.
COMPB	26	O	Error amplifier output of BuckB and compensation node for voltage-loop stability. The voltage at this node sets the target for the peak current through the inductor of BuckB. Clamping this voltage on the upper and lower ends provides current-limit protection for the external MOSFETs.

**Pin Functions (continued)**

NAME	NO.	TYPE	DESCRIPTION
DLYAB	21	O	The capacitor at the DLYAB pin sets the power-good delay interval used to de-glitch the outputs of the power-good comparators. Leaving this pin open sets the power-good delay to an internal default value of 20 $\mu$ s typical.
ENA	16	I	Enable input for BuckA (active-high with an internal pullup current source). An input voltage higher than 1.7 V enables the controller, whereas an input voltage lower than 0.7 V disables the controller. When both ENA and ENB are low, the device shuts down and consumes less than 4 $\mu$ A of current.
ENB	17	I	Enable input for BuckB (active-high with an internal pullup current source). An input voltage higher than 1.7 V enables the controller, whereas an input voltage lower than 0.7 V disables the controller. When both ENA and ENB are low, the device shuts down and consumes less than 4 $\mu$ A of current.
EXTSUP	37	I	One can use EXTSUP to supply the VREG regulator from one of the TPS43350-Q1 or TPS43351-Q1 buck regulator rails to reduce power dissipation in cases where there is an expectation of high VIN. If EXTSUP is unused, leave the pin open without a capacitor installed.
FBA	12	I	Feedback voltage pin for BuckA. The buck controller regulates the feedback voltage to the internal reference of 0.8 V. A suitable resistor divider network between the buck output and the feedback pin sets the desired output voltage.
FBB	27	I	Feedback voltage pin for BuckB. The buck controller regulates the feedback voltage to the internal reference of 0.8 V. A suitable resistor divider network between the buck output and the feedback pin sets the desired output voltage.
GA1	6	O	This output can drive the external high-side N-channel MOSFET for buck regulator BuckA. The output provides high peak currents to drive capacitive loads. The gate-drive reference is to a floating ground provided by PHA that has a voltage swing provided by CBA.
GA2	8	O	This output can drive the external low-side N-channel MOSFET for buck regulator BuckA. The output provides high peak currents to drive capacitive loads. VREG provides the voltage swing on this pin.
GB1	33	O	This output can drive the external high-side N-channel MOSFET for buck regulator BuckB. The output provides high peak currents to drive capacitive loads. The gate drive reference is to a floating ground provided by PHB that has a voltage swing provided by CBB.
GB2	31	O	This output can drive the external low-side N-channel MOSFET for buck regulator BuckB. The output provides high peak currents to drive capacitive loads. VREG provides the voltage swing on this pin.
GC2	4	O	This pin makes a floating output drive available to control the external P-channel MOSFET. This MOSFET can bypass the boost rectifier diode or a reverse-protection diode when the boost is not switching or if boost is disabled, and thus reduce power losses.
NC	2, 3, 18, 36	–	No connection
PGNDA	9	GND	Power ground connection to the source of the low-side N-channel MOSFETs of BuckA.
PGNDB	30	GND	Power ground connection to the source of the low-side N-channel MOSFETs of BuckB
PGA	15	O	Open-drain power-good indicator pin for BuckA. An internal power-good comparator monitors the voltage at the feedback pin and pulls this output low when the output voltage falls below 93% of the set value or if either VIN or VBAT drops below its respective undervoltage threshold.
PGB	24	O	Open-drain power-good indicator pin for BuckB. An internal power-good comparator monitors the voltage at the feedback pin and pulls this output low when the output voltage falls below 93% of the set value or if either VIN or VBAT drops below its respective undervoltage threshold..
PHA	7	O	Switching terminal of buck regulator BuckA, providing a floating ground reference for the high-side MOSFET gate-driver circuitry and used to sense current reversal in the inductor when discontinuous-mode operation is desired.
PHB	32	O	Switching terminal of buck regulator BuckB, providing a floating ground reference for the high-side MOSFET gate-driver circuitry and used to sense current reversal in the inductor when discontinuous-mode operation is desired.
RT	22	O	Connecting a resistor to ground on this pin sets the operational switching frequency of the buck and boost controllers. A short circuit to ground on this pin defaults operation to 400 kHz for the buck controllers and 200 kHz for the boost controller.
SA1	10	I	High-impedance differential-voltage inputs from the current-sense element (sense resistor or inductor DCR) for each buck controller. Choose the current-sense element to set the maximum current through the inductor based on the current-limit threshold (subject to tolerances) and considering the typical characteristics across duty cycle and VIN. (SA1 positive node, SA2 negative node).
SA2	11	I	
SB1	29	I	High-impedance differential voltage inputs from the current-sense element (sense resistor or inductor DCR) for each buck controller. Choose the current-sense element to set the maximum current through the inductor based on the current-limit threshold (subject to tolerances) and considering the typical characteristics across duty cycle and VIN (SB1 positive node, SB2 negative node).
SB2	28	I	
SSA	14	O	Soft-start or tracking input for buck controller BuckA. The buck controller regulates the FBA voltage to the lower of 0.8 V or the SSA pin voltage. An internal pullup current source of 1 $\mu$ A is present at the pin, and an appropriate capacitor connected here sets the soft-start ramp interval. Alternatively, a resistor divider connected to another supply can provide a tracking input to this pin.
SSB	25	O	Soft-start or tracking input for buck controller BuckB. The buck controller regulates the FBB voltage to the lower of 0.8 V or the SSB pin voltage. An internal pullup current source of 1 $\mu$ A is present at the pin, and an appropriate capacitor connected here sets the soft-start ramp interval. Alternatively, a resistor divider connected to another supply can provide a tracking input to this pin.
SYNC	20	I	If an external clock is present on this pin, the device detects it, and the internal PLL locks on to the external clock. This overrides the internal oscillator frequency. The device can synchronize to frequencies from 150 kHz to 600 kHz. A high logic level on this pin ensures forced continuous-mode operation of the buck controllers and inhibits transition to low-power mode. An open or low allows discontinuous-mode operation and entry into low-power mode at light loads. On the TPS43351-Q1, a high level enables frequency-hopping spread spectrum, whereas an open or a low level disables it.

**Pin Functions (continued)**

NAME	NO.	TYPE	DESCRIPTION
VBAT	1	PWR	Supply pin
VIN	38	PWR	Main input pin. This is the buck controller input pin. Additionally, it powers the internal control circuits of the device.
VREG	35	O	The device requires an external capacitor on this pin to provide a regulated supply for the gate drivers of the buck and boost controllers. TI recommends capacitance on the order of 4.7 $\mu$ F. The regulator obtain its power from either or EXTSUP. This pin has current-limit protection; do not use it to drive any other loads.
PowerPAD	Pad	GND	PowerPAD thermal pad is not directly connected to any leads of the package. However, it is electrically and thermally connected to the substrate, which is the ground of the device.

## 6 Specifications

### 6.1 Absolute Maximum Ratings

 over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
Voltage	Input voltage: VBAT	-0.3	60	V
Voltage (Buck function: BuckA and BuckB)	Ground: PGND <sub>A</sub> –AGND, PGND <sub>B</sub> –AGND	-0.3	0.3	V
	Enable inputs: ENA, ENB	-0.3	60	V
	Bootstrap inputs: CBA, CBB	-0.3	68	V
	Bootstrap inputs: CBA–PHA, CBB–PHB	-0.3	8.8	V
	Phase inputs: PHA, PHB	-0.7	60	V
	Phase inputs: PHA, PHB (for 150 ns)	-1		V
	Feedback inputs: FBA, FBB	-0.3	13	V
	Error amplifier outputs: COMPA, COMPB	-0.3	13	V
	High-side MOSFET driver: GA1–PHA, GB1–PHB	-0.3	8.8	V
	Low-side MOSFET drivers: GA2–PGND <sub>A</sub> , GB2–PGND <sub>B</sub>	-0.3	8.8	V
	Current-sense voltage: SA1, SA2, SB1, SB2	-0.3	13	V
	Soft start: SSA, SSB	-0.3	13	V
	Power-good output: PGA, PGB	-0.3	13	V
	Power-good delay: DLYAB	-0.3	13	V
Switching-frequency timing resistor: RT	-0.3	13	V	
	SYNC, EXTSUP	-0.3	13	V
Voltage (PMOS driver)	P-channel MOSFET driver: GC2	-0.3	60	V
	P-channel MOSFET driver: -GC2	-0.3	8.8	V
Voltage (Gate driver)	Gate-driver supply: VREG	-0.3	8.8	V
Temperature	Junction temperature: T <sub>J</sub>	-40	150	°C
	Operating temperature: T <sub>A</sub>	-40	125	°C
	Storage temperature: T <sub>stg</sub>	-55	165	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. All voltage values are with respect to AGND, unless otherwise stated.

### 6.2 ESD Ratings

		VALUE	UNIT	
V <sub>(ESD)</sub>	Electrostatic discharge	Human-body model (HBM) AEC-Q100 Classification Level H2 <sup>(1)</sup>	±2000	
		Charged-device model (CDM) AEC-Q100 Classification Level C2	Pins 12, 21, 22, and 27	±400
			Pins 1 and 20	±750
			All other pins	±500
		Machine model (MM)	Pins 15 and 24	±150
			All other pins	±200

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
Buck function: BuckA and BuckB voltage	Input voltage: , VBAT	4	40	V
	Enable inputs: ENA, ENB	0	40	V
	Boot inputs: CBA, CBB	4	48	V
	Phase inputs: PHA, PHB	-0.6	40	V
	Current-sense voltage: SA1, SA2, SB1, SB2	0	11	V
	Power-good output: PGA, PGB	0	11	V
	SYNC, EXTSUP	0	9	V
Temperature	Operating temperature: T <sub>A</sub>	-40	125	°C

### 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TPS4333-Q1	UNIT
		DAP (HTSSOP)	
		38 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	27.3	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	19.6	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	15.9	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	0.24	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	6.6	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	1.2	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

### 6.5 DC Electrical Characteristics

V<sub>IN</sub> = 8 V to 18 V, T<sub>J</sub> = -40°C to 150°C (unless otherwise noted)

NO.	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
1.0	<b>Input Supply</b>						
1.1	V <sub>Bat</sub>	Supply voltage	After initial start-up, condition is satisfied.	4		40	V
1.2	V <sub>IN</sub>	Input voltage required for device on initial start-up		6.5		40	V
		Buck regulator operating range after initial start-up		4		40	V
1.3	V <sub>IN UV</sub>	Buck undervoltage lockout	V <sub>IN</sub> falling. After a reset, initial start-up conditions may apply. <sup>(1)</sup>	3.5	3.6	3.8	V
			V <sub>IN</sub> rising. After a reset, initial start-up conditions may apply. <sup>(1)</sup>		3.8	4	V
1.5	I <sub>q_LPM_</sub>	LPM quiescent current: T <sub>A</sub> = 25°C <sup>(2)</sup>	V <sub>IN</sub> = 13 V, BuckA: LPM, BuckB: off		30	40	μA
			V <sub>IN</sub> = 13 V, BuckB: LPM, BuckA: off		30	40	μA
			V <sub>IN</sub> = 13 V, BuckA, B: LPM		35	45	μA
1.6	I <sub>q_LPM</sub>	LPM quiescent current: T <sub>A</sub> = 125°C <sup>(2)</sup>	V <sub>IN</sub> = 13 V, BuckA: LPM, BuckB: off		40	50	μA
			V <sub>IN</sub> = 13 V, BuckB: LPM, BuckA: off		40	50	μA
			V <sub>IN</sub> = 13 V, BuckA, B: LPM		45	55	μA
1.7	I <sub>q_NRM</sub>	Quiescent current: T <sub>A</sub> = 25°C <sup>(2)</sup>	Normal operation, SYNC = High		4.85	5.3	mA
			V <sub>IN</sub> = 13 V, BuckA: CCM, BuckB: off		7	7.6	mA
			V <sub>IN</sub> = 13 V, BuckB: CCM, BuckA: off				
			V <sub>IN</sub> = 13 V, BuckA, B: CCM				

(1) If V<sub>BAT</sub> and V<sub>REG</sub> remain adequate, the buck can continue to operate if V<sub>IN</sub> is > 3.8 V.

(2) Quiescent current specification is non-switching current consumption without including the current in the external feedback resistor divider.



## DC Electrical Characteristics (continued)

 $V_{IN} = 8\text{ V to }18\text{ V}$ ,  $T_J = -40^\circ\text{C to }150^\circ\text{C}$  (unless otherwise noted)

NO.	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
1.8	$I_{q\_NRM}$ Quiescent current: $T_A = 125^\circ\text{C}^{(2)}$	Normal operation, SYNC = High		5	5.5	mA	
		$V_{IN} = 13\text{ V}$ , BuckA: CCM, BuckB: off		7.5	8	mA	
		$V_{IN} = 13\text{ V}$ , BuckB: CCM, BuckA: off					
		$V_{IN} = 13\text{ V}$ , BuckA, B: CCM					
1.9	$I_{BAT\_sh}$ Shutdown current	BuckA, B: off, $V_{BAT} = 13\text{ V}$		3	5	$\mu\text{A}$	
2.0	<b>Input Voltage - Overvoltage Lockout</b>						
2.1	$V_{OVLO}$ Overvoltage shutdown	$V_{IN}$ rising	45	46	47	V	
		$V_{IN}$ falling	43	44	45	V	
2.2	$OVLO_{Hys}$ Hysteresis		1	2	3	V	
2.3	$OVLO_{filter}$ Filter time			5		$\mu\text{s}$	
	<b>Gate Driver for PMOS</b>						
3.1	$r_{DS(on)}$ PMOS OFF			10	20	$\Omega$	
3.2	$I_{PMOS\_ON}$ Gate current	$V_{IN} = 13.5\text{ V}$ , $V_{GS} = -5\text{ V}$	10			mA	
3.3	$t_{delay\_ON}$ Turnon delay	$C = 10\text{ nF}$		5	10	$\mu\text{s}$	
4.0	<b>Buck Controllers</b>						
4.1	$V_{BuckA/B}$ Adjustable output voltage range		0.9		11	V	
4.2	$V_{REF\_NRM}$ Internal reference voltage and tolerance in normal mode	Measure FBx pin	0.792	0.8	0.808	V	
			-1%		1%		
4.3	$V_{REF\_LPM}$ Internal reference voltage and tolerance in low-power mode	Measure FBx pin	0.784	0.8	0.816	V	
			-2%		2%		
4.4	$V_{SENSE}$	V sense for forward current limit in CCM	FBx = 0.75 V (low duty cycles)	60	75	90	mV
4.5		V sense for reverse current limit in CCM	FBx = 1 V	-65	-37.5	-23	mV
4.6	$V_{I-Foldback}$	V sense for output short	FBx = 0 V	17	32.5	48	mV
4.7	$t_{dead}$	Shoot-through delay, blanking time		100		ns	
4.8	$DC_{NRM}$	High-side minimum on-time		100		ns	
		Maximum duty cycle (digitally controlled)		98.75%			
4.9	$DC_{LPM}$	Duty cycle LPM			80%		
4.10	$I_{LPM\_Entry}$	LPM entry threshold load current as fraction of maximum set load current	The exit threshold is specified to be always higher than entry threshold		1%	See <sup>(3)</sup>	
	$I_{LPM\_Exit}$	LPM exit threshold load current as fraction of maximum set load current	The exit threshold is specified to be always higher than entry threshold	See <sup>(3)</sup>	10%		
	<b>High-Side External NMOS Gate Drivers for Buck Controller</b>						
4.11	$I_{GX1\_peak}$	Gate driver peak current		1.5		A	
4.12	$r_{DS(on)}$	Source and sink driver	$V_{REG} = 5.8\text{ V}$ , $I_{GX1}$ current = 200 mA		2	$\Omega$	
	<b>Low-Side NMOS Gate Drivers for Buck Controller</b>						
4.13	$I_{GX2\_peak}$	Gate-driver peak current		1.5		A	
4.14	$r_{DS(on)}$	Source and sink driver	$V_{REG} = 5.8\text{ V}$ , $I_{GX2}$ current = 200 mA		2	$\Omega$	
	<b>Error Amplifier (OTA) for Buck Converters</b>						
4.15	$G_{mBUCK}$	Transconductance	COMP A, COMP B = 0.8 V, source/sink = 5 $\mu\text{A}$ , test in feedback loop	0.72	1	1.35	mS
4.16	$I_{PULLUP\_FBx}$	Pullup current at FBx pins	FBx = 0 V	50	100	200	nA
5.0	<b>Digital Inputs: ENA, ENB, SYNC</b>						
5.1	$V_{IH}$	Higher threshold	$V_{IN} = 13\text{ V}$	1.7		V	
5.2	$V_{IL}$	Lower threshold	$V_{IN} = 13\text{ V}$		0.7	V	
5.3	$R_{IH\_SYNC}$	Resistance	$V_{SYNC} = 5\text{ V}$	500		k $\Omega$	
5.5	$I_{IL\_ENx}$	Pullup current source on ENA, ENB	$V_{ENx} = 0\text{ V}$		0.5	2	$\mu\text{A}$

(3) The exit threshold specification is to be always higher than the entry threshold.

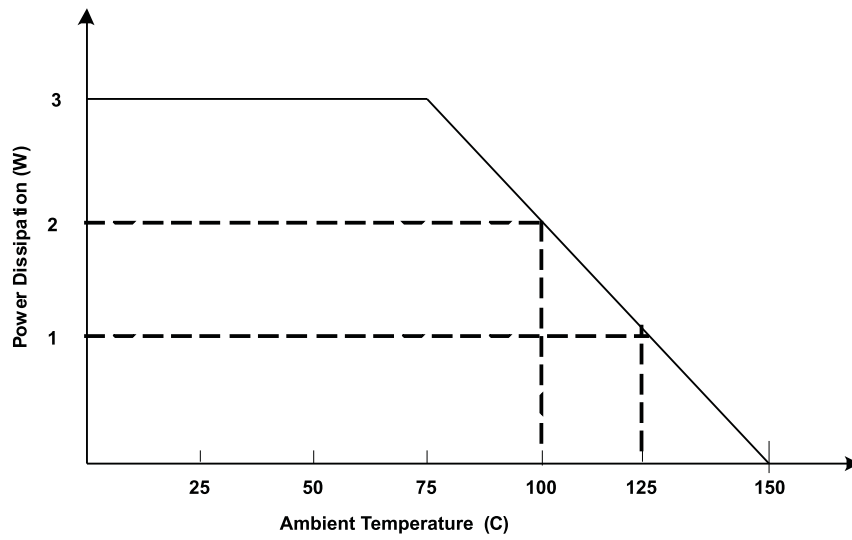


## DC Electrical Characteristics (continued)

 $V_{IN} = 8\text{ V to }18\text{ V}$ ,  $T_J = -40^{\circ}\text{C to }150^{\circ}\text{C}$  (unless otherwise noted)

NO.	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
6.0	<b>Switching Parameters – Buck DC-DC Controllers</b>							
6.1	$f_{SW\_Buck}$ Buck switching frequency	RT pin: GND	360	400	440	kHz		
6.2	$f_{SW\_Buck}$ Buck switching frequency	RT pin: 60-k $\Omega$ external resistor	360	400	440	kHz		
6.3	$f_{SW\_adj}$ Buck adjustable range with external resistor	RT pin: external resistor	150		600	kHz		
6.4	$f_{SYNC}$ Buck synchronization range	External clock input	150		600	kHz		
6.5	$f_{SS}$ Spread-spectrum spreading	TPS43351-Q1 only		5%				
7.0	<b>Internal Gate-Driver Supply</b>							
7.1	$V_{REG}$	Internal regulated supply	$V_{IN} = 8\text{ V to }18\text{ V}$ , $EXTSUP = 0\text{ V}$ , $SYNC = \text{High}$		5.5	5.8	6.1	V
		Load regulation	$I_{VREG} = 0\text{ mA to }100\text{ mA}$ , $EXTSUP = 0\text{ V}$ , $SYNC = \text{High}$			0.2%	1%	
7.2	$V_{REG(EXTSUP)}$	Internal regulated supply	$EXTSUP = 8.5\text{ V}$		7.2	7.5	7.8	V
		Load regulation	$I_{EXTSUP} = 0\text{ mA to }125\text{ mA}$ , $SYNC = \text{High}$ , $EXTSUP = 8.5\text{ V to }13\text{ V}$			0.2%	1%	
7.3	$V_{EXTSUP\_th}$ EXTSUP switch-over voltage threshold	$I_{VREG} = 0\text{ mA to }100\text{ mA}$ , $EXTSUP$ ramping positive	4.4	4.6	4.8	V		
7.4	$V_{EXTSUP\_Hys}$ EXTSUP switch-over hysteresis		150		250	mV		
7.5	$I_{REG\_Limit}$ Current limit on VREG	$EXTSUP = 0\text{ V}$ , normal mode as well as LPM	100		400	mA		
7.6	$I_{REG\_EXTSUP\_Limit}$ Current limit on VREG when using EXTSUP	$I_{VREG} = 0\text{ mA to }100\text{ mA}$ , $EXTSUP = 8.5\text{ V}$ , $SYNC = \text{High}$	125		400	mA		
8.0	<b>Soft Start</b>							
8.1	$I_{SSx}$ Soft-start source current	$SSA$ and $SSB = 0\text{ V}$	0.75	1	1.25	$\mu\text{A}$		
9.0	<b>Oscillator (RT)</b>							
9.1	$V_{RT}$ Oscillator reference voltage			1.2		V		
10.0	<b>Power-Good / Delay</b>							
10.1	$PG_{pullup}$ Pullup for A and B to Sx2			50		k $\Omega$		
10.2	$PG_{th1}$ Power-good threshold	FBx falling	-5%	-7%	-9%			
10.3	$PG_{hys}$ Hysteresis			2%				
10.4	$PG_{drop}$ Voltage drop	$I_{PGA} = 5\text{ mA}$			450	mV		
10.5		$I_{PGA} = 1\text{ mA}$			100	mV		
10.6	$PG_{leak}$ Leakage	$VSx2 = VPGx = 13\text{ V}$			1	$\mu\text{A}$		
10.7	$t_{deglitch}$ Power-good deglitch time		2		16	$\mu\text{s}$		
10.8	$t_{delay}$ Reset delay	External capacitor = 1 nF $V_{BuckX} < PG_{th1}$		1		ms		
10.9	$t_{delay\_fix}$ Fixed reset delay	No external capacitor, pin open		20	50	$\mu\text{s}$		
10.10	$I_{OH}$ Activate current source (current to charge external capacitor)		30	40	50	$\mu\text{A}$		
10.11	$I_{IL}$ Activate current sink (current to discharge external capacitor)		30	40	50	$\mu\text{A}$		
11.0	<b>Overtemperature Protection</b>							
11.1	$T_{shutdown}$ Junction temperature shutdown threshold		150	165		$^{\circ}\text{C}$		
11.2	$T_{hys}$ Junction temperature hysteresis			15		$^{\circ}\text{C}$		

**6.6 Power Dissipation Derating Profile, 38-Pin HTTSOP PowerPAD Package**



**Figure 1. Power Dissipation Derating Profile Based on High-K JEDEC PCB**

### 6.7 Typical Characteristics

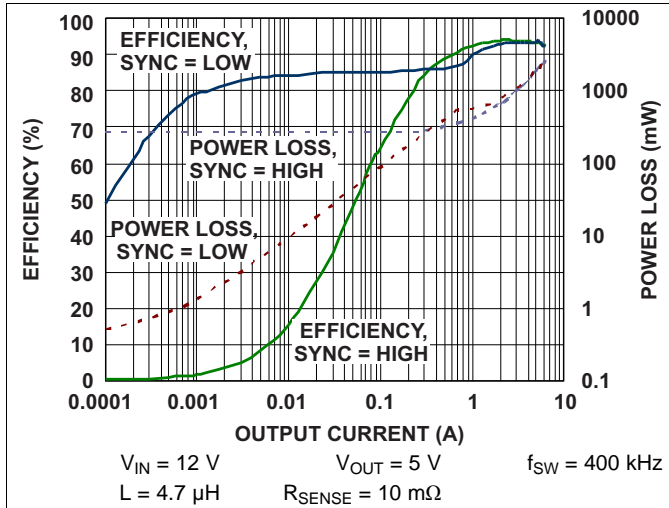


Figure 2. Efficiency Across Output Currents (Bucks)

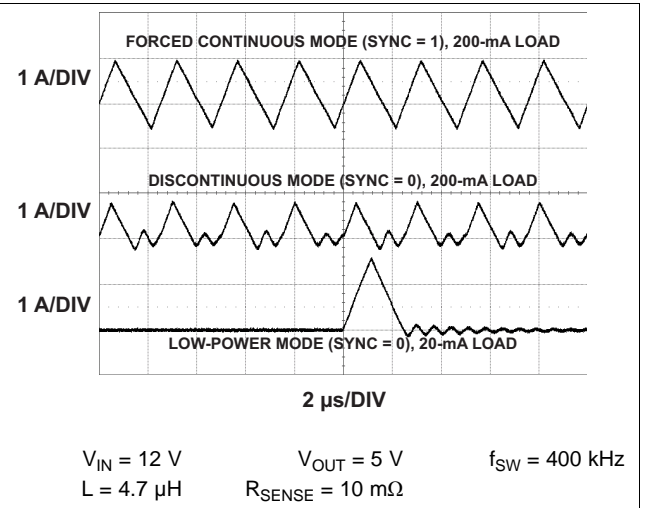


Figure 3. Inductor Currents (Buck)

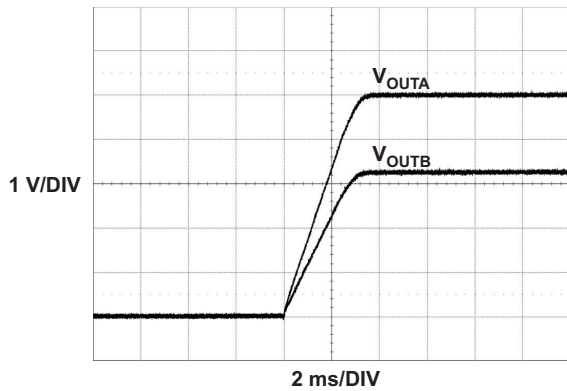


Figure 4. Soft-Start Outputs (Buck)

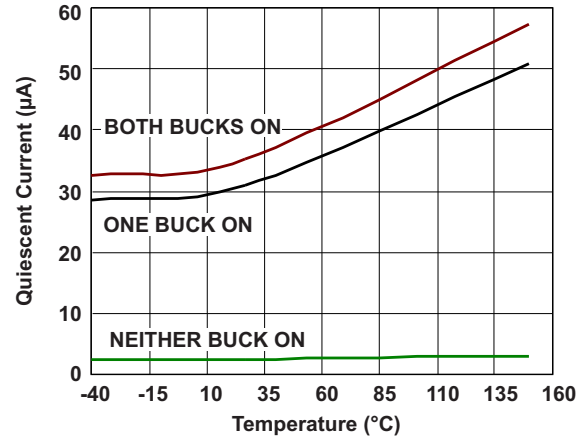


Figure 5. No-Load Quiescent Current across Temperature

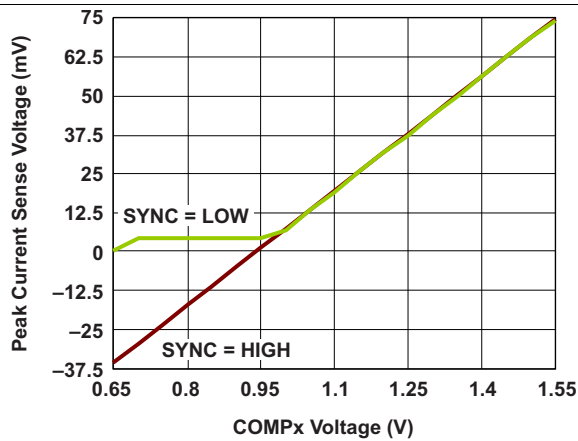


Figure 6. BUCKx Peak Current Limit vs COMPx Voltage

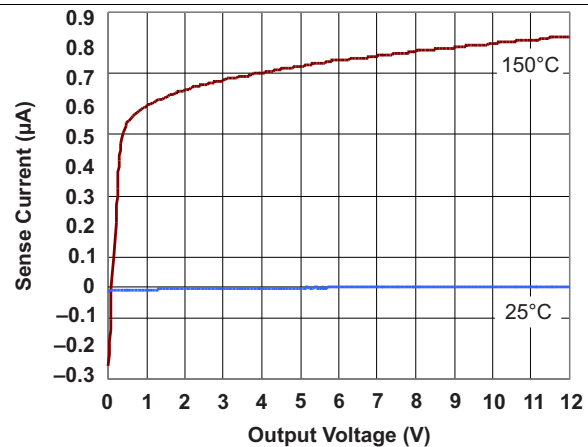


Figure 7. Current-Sense Pins Input Current (Buck)

**Typical Characteristics (continued)**

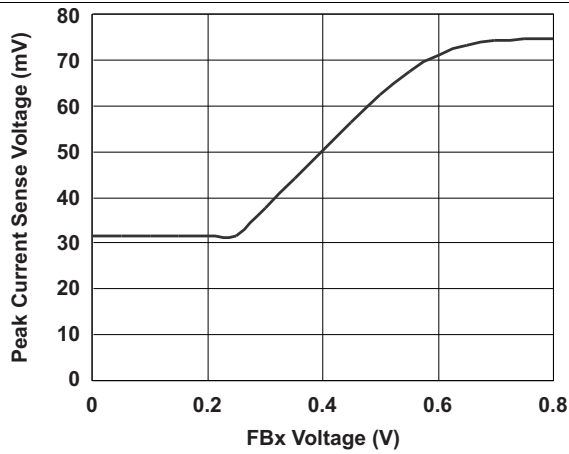


Figure 8. Foldback Current Limit (Buck)

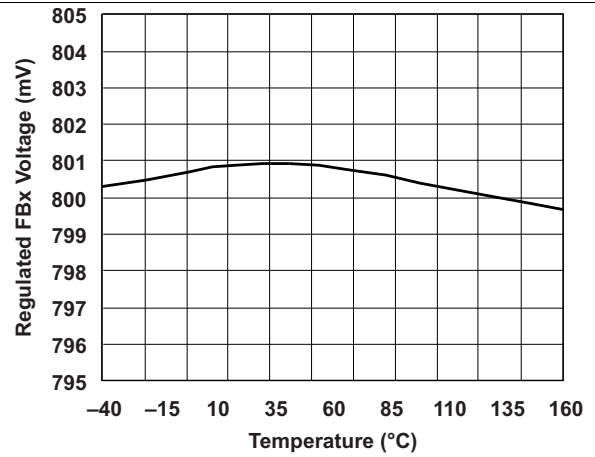


Figure 9. Regulated FBx Voltage vs Temperature (Buck)

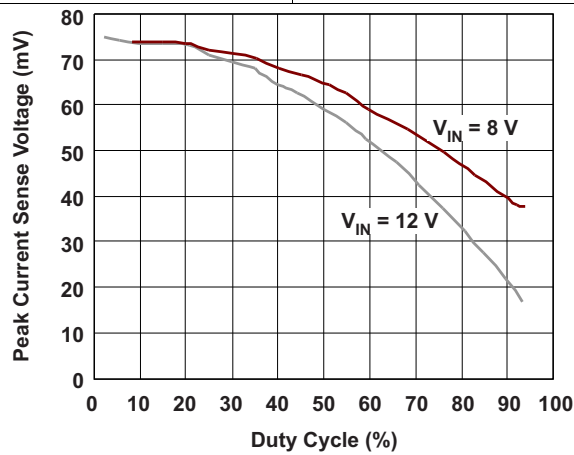


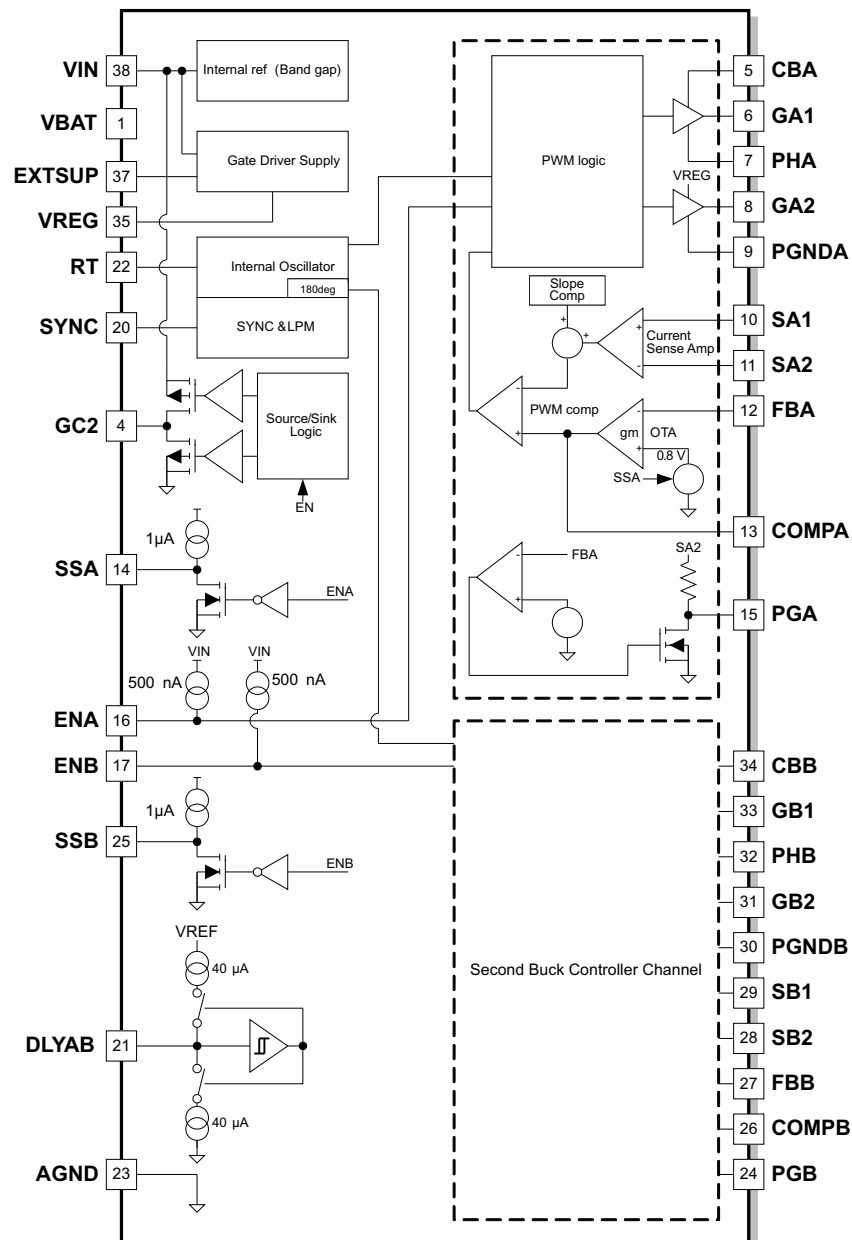
Figure 10. Current Limit vs Duty Cycle (Buck)

## 7 Detailed Description

### 7.1 Overview

The TPS43350-Q1 and TPS43351-Q1 devices feature two current-mode synchronous buck controllers. With light loads, the buck controllers can be enabled to automatically operate in low-power mode, consuming just 30  $\mu\text{A}$  of quiescent current. The buck controllers have independent soft-start capability and power-good indicators. Current foldback in the buck controllers provide external MOSFET protection. The switching frequency is programmable over 150 kHz to 600 kHz or can be synchronized to an external clock in the same range. Additionally, the TPS43351-Q1 offers frequency-hopping spread-spectrum operation.

### 7.2 Functional Block Diagram



Copyright © 2016, Texas Instruments Incorporated

## 7.3 Feature Description

### 7.3.1 Buck Controllers: Normal Mode PWM Operation

#### 7.3.1.1 Frequency Selection and External Synchronization

The buck controllers operate using constant-frequency peak-current mode control for optimal transient behavior and ease of component choices. The switching frequency is programmable between 150 kHz and 600 kHz, depending upon the resistor value at the RT pin. A short circuit to ground at this pin sets the default switching frequency to 400 kHz. Using a resistor at RT, one can set another frequency according to [Equation 1](#).

$$f_{\text{sw}} = \frac{X}{RT} \quad (X = 24 \text{ k}\Omega \times \text{MHz})$$

$$f_{\text{sw}} = 24 \times \frac{10^9}{RT} \quad (1)$$

For example:

- 600 kHz requires 40 k $\Omega$
- 150 kHz requires 160 k $\Omega$

It is also possible to synchronize to an external clock at the SYNC pin in the same frequency range of 150 kHz to 600 kHz. The device detects clock pulses at this pin, and an internal PLL locks on to the external clock within the specified range. The device can also detect a loss of clock at this pin, and on detection of this condition, the device sets the switching frequency to the internal oscillator. The two buck controllers operate at identical switching frequencies, 180 degrees out of phase.

#### 7.3.1.2 Enable Inputs

Independent enable inputs from the ENA and ENB pins enable the buck controllers. These are high-voltage pins, with a threshold of 1.7 V for the high level, and with direct connection to the battery permissible for self-bias. The low threshold is 0.7 V. Both these pins have internal pullup currents of 0.5  $\mu\text{A}$  (typical). As a result, an open circuit on these pins enables the respective buck controllers. But with both buck controllers disabled, the device shuts down and consumes a current less than 4  $\mu\text{A}$ .

#### 7.3.1.3 Feedback Inputs

The right resistor feedback divider network connected to the FBx (feedback) pins sets the output voltage. Choose this network such that the regulated voltage at the FBx pin equals 0.8 V. The FBx pins have a 100-nA pullup current source as a protection feature in case the pins open up as a result of physical damage.

#### 7.3.1.4 Soft-Start Inputs

In order to avoid large inrush currents, the buck controllers have independent programmable soft-start timers. The voltage at the SSx pins acts as the soft-start reference voltage. The 1- $\mu\text{A}$  pullup current available at the SSx pins, in combination with a suitably chosen capacitor, generates a ramp of the desired soft-start speed. After start-up, the pullup current ensures that this node is higher than the internal reference of 0.8 V, which then becomes the reference for the buck controllers. Use [Equation 2](#) to calculate the soft-start ramp time..

$$C_{\text{SS}} = \frac{I_{\text{SS}} \times \Delta t}{\Delta V} \quad (\text{Farads})$$

where

- $I_{\text{SS}} = 1 \mu\text{A}$  (typical)
- $\Delta V = 0.8 \text{ V}$
- $C_{\text{SS}}$  is the required capacitor for  $\Delta t$ , the desired soft-start time. (2)

An alternative use of the soft-start pins is as tracking inputs. In this case, connect them to the supply to be tracked via a suitable resistor-divider network.

## Feature Description (continued)

### 7.3.1.5 Current-Mode Operation

Peak-current-mode control regulates the peak current through the inductor to maintain the output voltage at its set value. The error between the feedback voltage at FBx and the internal reference produces a signal at the output of the error amplifier (COMPx) which serves as a target for the peak inductor current. The device senses the current through the inductor as a differential voltage at Sx1–Sx2 and compares voltage with this target during each cycle. A fall or rise in load current produces a rise or fall in voltage at FBx, causing COMPx to fall or rise respectively, thus increasing or decreasing the current through the inductor until the average current matches the load. This process maintains the output voltage in regulation.

The top N-channel MOSFET turns on at the beginning of each clock cycle and stays on until the inductor current reaches its peak value. Once this MOSFET turns off, and after a small delay (shoot-through delay) the lower N-channel MOSFET turns on until the start of the next clock cycle. In dropout operation, the high-side MOSFET stays on continuously. In every fourth clock cycle, there is a limit on the duty cycle of 95% in order to charge the bootstrap capacitor at CBx. This allows a maximum duty cycle of 98.75% for the buck regulators. During dropout, the buck regulator switches at one-fourth of its normal frequency.

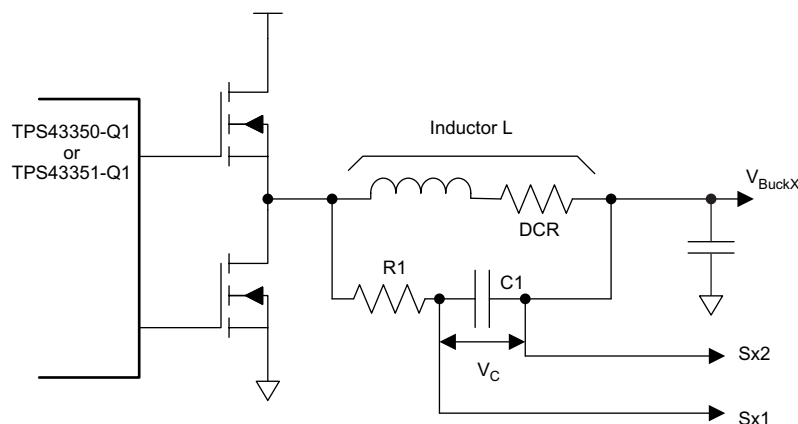
### 7.3.1.6 Current Sensing and Current Limit With Foldback

Clamping of the maximum value of COMPx is such as to limit the maximum current through the inductor to a specified value. When the output of the buck regulator (and hence the feedback value at FBx) falls to a low value due to a short-circuit or overcurrent condition, the clamped voltage at COMPx successively decreases, thus providing current foldback protection. This protects the high-side external MOSFET from excess current (forward-direction current limit).

Similarly, if a fault condition shorts the output to a high voltage and the low-side MOSFET turns fully on, the COMPx node drops low. A clamp is on its lower end as well, in order to limit the maximum current in the low-side MOSFET (reverse-direction current limit).

An external resistor senses the current through the inductor. Choose the sense resistor such that the maximum forward peak current in the inductor generates a voltage of 75 mV across the sense pins. This specified value is for low duty cycles only. At typical duty-cycle conditions around 40% (assuming 5-V output and 12-V input), 50 mV is a more reasonable value, considering tolerances and mismatches. The typical characteristics provide a guide for using the correct current-limit sense voltage.

The current-sense pins Sx1 and Sx2 are high-impedance pins with low leakage across the entire output range. This allows DCR current sensing using the dc resistance of the inductor for higher efficiency. Figure 11 shows DCR sensing. Here, the series resistance (DCR) of the inductor is the sense element. Place the filter components close to the device for noise immunity. Remember that while the DCR sensing gives high efficiency, it is inaccurate due to the temperature sensitivity and a wide variation of the parasitic inductor series resistance. Hence, it may often be advantageous to use the more-accurate sense resistor for current sensing.



Copyright © 2016, Texas Instruments Incorporated

Figure 11. DCR Sensing Configuration



## Feature Description (continued)

### 7.3.1.7 Slope Compensation

Optimal slope compensation, which is adaptive to changes in input voltage and duty cycle, allows stable operation at all conditions. For optimal performance of this circuit, choose the inductor and sense resistor according to [Equation 3](#).

$$\frac{L \times f_{sw}}{R_s} = 200$$

where

- L is the buck regulator inductor in henries.
  - $R_s$  is the sense resistor in ohms.
  - $f_{sw}$  is the buck-regulator switching frequency in hertz.
- (3)

### 7.3.1.8 Power-Good Outputs and Filter Delays

Each buck controller has an independent power-good comparator monitoring the feedback voltage at the FBx pins and indicating whether the output voltage has fallen below a specified power-good threshold. This threshold has a typical value of 93% of the regulated output voltage. The power-good indicator is available as an open-drain output at the PGx pins. An internal 50-k $\Omega$  pullup resistor to Sx2 is available, or use of an external resistor is possible. Shutdown of a buck controller causes an internal pulldown of the power-good indicator. Connecting the pullup resistor to a rail other than the output of that particular buck channel causes a constant current flow through the resistor when the buck controller is in the powered-down state.

In order to avoid triggering the power-good indicators due to noise or fast transients on the output voltage, the device uses an internal delay circuit for de-glitching. Similarly, when the output voltage returns to its set value after a long negative transient, assertion of the power-good indicator (release of the open-drain pin) occurs after the same delay. Use of this delay can pause the delay of the reset. Program the duration of the delay of by using a suitable capacitor at the DLYAB pin according to [Equation 4](#).

$$\frac{t_{DELAY}}{C_{DLYAB}} = \frac{1 \text{ ms}}{1 \text{ nF}}$$
(4)

When the DLYAB pin is open, the delay setting is for a default value of 20  $\mu$ s typical. The power-good delay timing is common to both the buck rails, but the power-good comparators and indicators function independently.

### 7.3.1.9 Light-Load PFM Mode

An external clock or a high level on the SYNC pin results in forced continuous-mode operation of the bucks. An open or low on the SYNC pin allows the buck controllers to operate in discontinuous mode at light loads by turning off the low-side MOSFET on detection of a zero-crossing in the inductor current.

In discontinuous mode, as the load decreases, the duration when both the high-side and low-side MOSFETs turn off increases (deep discontinuous mode). In case the duration exceeds 60% of the clock period and  $V_{BAT} > 8 \text{ V}$ , the buck controller switches to a low-power operation mode. The design ensures that this typically occurs at 1% of the set full-load current if the inductor and the sense resistor have been chosen appropriately as recommended in the [Slope Compensation](#) section.

In low-power PFM mode, the buck monitors the FBx voltage and compares it with the 0.8-V internal reference. Whenever the FBx value falls below the reference, the high-side MOSFET turns on for a pulse duration inversely proportional to the difference – Sx2. At the end of this on-time, the high-side MOSFET turns off and the current in the inductor decays until it becomes zero. The low-side MOSFET does not turn on. The next pulse occurs the next time FBx falls below the reference value. This results in a constant volt-second  $t_{on}$  hysteretic operation with a total device quiescent current consumption of 30  $\mu$ A when a single buck channel is active and 35  $\mu$ A when both channels are active.

As the load increases, the pulses become more and more frequent and move closer to each other until the current in the inductor becomes continuous. At this point, the buck controller returns to normal fixed-frequency current-mode control. Another criterion to exit the low-power mode is when  $V_{IN}$  falls low enough to require higher than 80% duty cycle of the high-side MOSFET.

## Feature Description (continued)

The TPS43350-Q1 and TPS43351-Q1 can support the full current load during low-power mode until the transition to normal mode takes place. The design ensures that exit of the low-power mode occurs at 10% (typical) of full-load current if the selection of inductor and sense resistor is as recommended. Moreover, there is always a hysteresis between the entry and exit thresholds to avoid oscillating between the two modes.

In the event that both buck controllers are active, low-power mode is only possible when both buck controllers have light loads that are low enough for low-power-mode entry.

### 7.3.2 Frequency-Hopping Spread Spectrum (TPS43351-Q1 Only)

The TPS43351-Q1 features a frequency-hopping pseudo-random spectrum spreading architecture. On this device, whenever the SYNC pin is high, the internal oscillator frequency varies from one cycle to the next within a band of  $\pm 5\%$  around the value programmed by the resistor at the RT pin. The implementation uses a linear feedback shift register that changes the frequency of the internal oscillator based on a digital code. The shift register is long enough to make the hops pseudo-random in nature and is designed in such a way that the frequency shifts only by one step at each cycle to avoid large jumps in the buck switching frequencies.

Table 1. Frequency Hopping Control

SYNC TERMINAL	FREQUENCY SPREAD SPECTRUM (FSS)	COMMENTS
External clock	Not active	Device in forced continuous mode, internal PLL locks into external clock between 150 kHz and 600 kHz.
Low or open	Not active	Device can enter discontinuous mode. Automatic LPM entry and exit, depending on load conditions
High	TPS43350-Q1: FSS not active	Device in forced continuous mode
	TPS43351-Q1: FSS active	

### 7.3.3 Gate-Driver Supply (VREG, EXTSUP)

The gate-driver supplies of the buck and boost controllers are from an internal linear regulator whose output (5.8 V typical) is on the VREG pin and requires decoupling with a ceramic capacitor in the range of 3.3  $\mu\text{F}$  to 10  $\mu\text{F}$ . This pin has internal current-limit protection; do not use it to power any other circuits.

VIN powers the VREG linear regulator by default when the EXTSUP voltage is lower than 4.6 V (typical). In case VIN expected to go to high levels, there can be excessive power dissipation in this regulator, especially at high switching frequencies and when using large external MOSFETs. In this case, it is advantageous to power this regulator from the EXTSUP pin, which can be connected to a supply lower than  $V_{\text{IN}}$  but high enough to provide the gate drive. When the voltage on EXTSUP is greater than 4.6 V, the linear regulator automatically switches to EXTSUP as its input, to provide this advantage. Efficiency improvements are possible when using one of the switching regulator rails from the TPS4335x-Q1 or any other voltage available in the system to power EXTSUP. The maximum voltage for application to EXTSUP is 9 V.

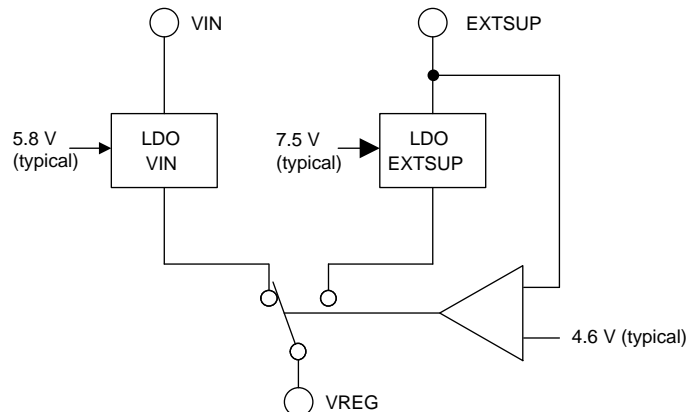
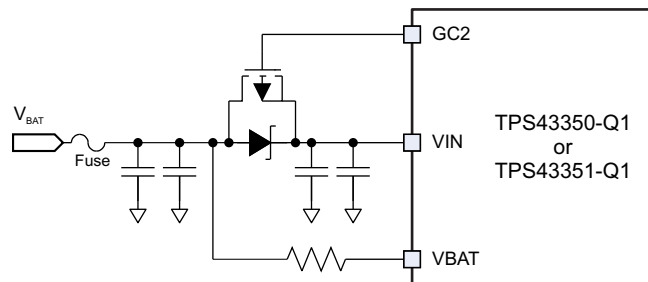


Figure 12. Internal Gate-Driver Supply

Using a voltage above 5.8 V (sourced by VIN) for EXTSUP is advantageous, as it provides a large gate drive and hence better on-resistance of the external MOSFETs. When using EXTSUP, always keep the buck rail supplying EXTSUP enabled. Alternatively, if it is necessary to switch off the buck rail supplying EXTSUP, place a diode between the buck rail and EXTSUP. During low-power mode, the EXTSUP functionality is not available. The internal regulator operates as a shunt regulator powered from VIN and has a typical value of 7.5 V. Current-limit protection for VREG is available in low-power mode as well. If EXTSUP is unused, leave the pin open without a capacitor installed.

### 7.3.4 External P-Channel Drive (GC2) and Reverse-Battery Protection

The TPS4335x-Q1 includes a gate driver for an external P-channel MOSFET which can be connected across the reverse-battery diode. This is useful to reduce power losses and the voltage drop over a typical diode. The gate driver provides a swing of 6 V typical below the  $V_{IN}$  voltage in order to drive a P-channel MOSFET.



Copyright © 2016, Texas Instruments Incorporated

**Figure 13. Reverse-Battery Protection Option**

### 7.3.5 Undervoltage Lockout and Overvoltage Protection

The TPS4335x-Q1 starts up at a  $V_{IN}$  voltage of 6.5 V (minimum), required for the internal supply (VREG). Once it has started up, the device operates down to a  $V_{IN}$  voltage of 3.6 V; below this voltage level, the undervoltage lockout disables the device. Note: if  $V_{IN}$  drops,  $V_{REG}$  drops as well; hence, the gate-drive voltage decreases, whereas the digital logic is fully functional. A voltage of 46 V at  $V_{IN}$  triggers the overvoltage comparator, which shuts down the device. In order to prevent transient spikes from shutting down the device, under- and overvoltage protection have filter times of 5  $\mu$ s (typical).

When the voltages return to the normal operating region, the enabled switching regulators start with a new soft-start ramp for the buck regulators.

### 7.3.6 Thermal Protection

The TPS4335x-Q1 protects itself from overheating using an internal thermal shutdown circuit. If the die temperature exceeds the thermal shutdown threshold of 165°C due to excessive power dissipation (for example, due to fault conditions such as a short circuit at the gate drivers or VREG), the controllers turn off. Then restart when the temperature has fallen by 15°C.

## 7.4 Device Functional Modes

Table 2 lists the modes of operation for the device.

**Table 2. Mode of Operation**

ENABLE AND INHIBIT PINS			BUCK CONTROLLER STATUS	DEVICE STATUS	QUIESCENT CURRENT
ENA	ENB	SYNC			
Low	Low	X	Shutdown	Shutdown	Approximately 4 $\mu$ A
Low	High	Low	BuckB running	BuckB: LPM enabled	Approximately 30 $\mu$ A (light loads)
		High		BuckB: LPM inhibited	mA range
High	Low	Low	BuckA running	BuckA: LPM enabled	Approximately 30 $\mu$ A (light loads)
		High		BuckA: LPM inhibited	mA range
High	High	Low	BuckA and BuckB running	BuckA and BuckB: LPM enabled	Approximately 35 $\mu$ A (light loads)
		High		BuckA and BuckB: LPM inhibited	mA range

## 8 Application and Implementation

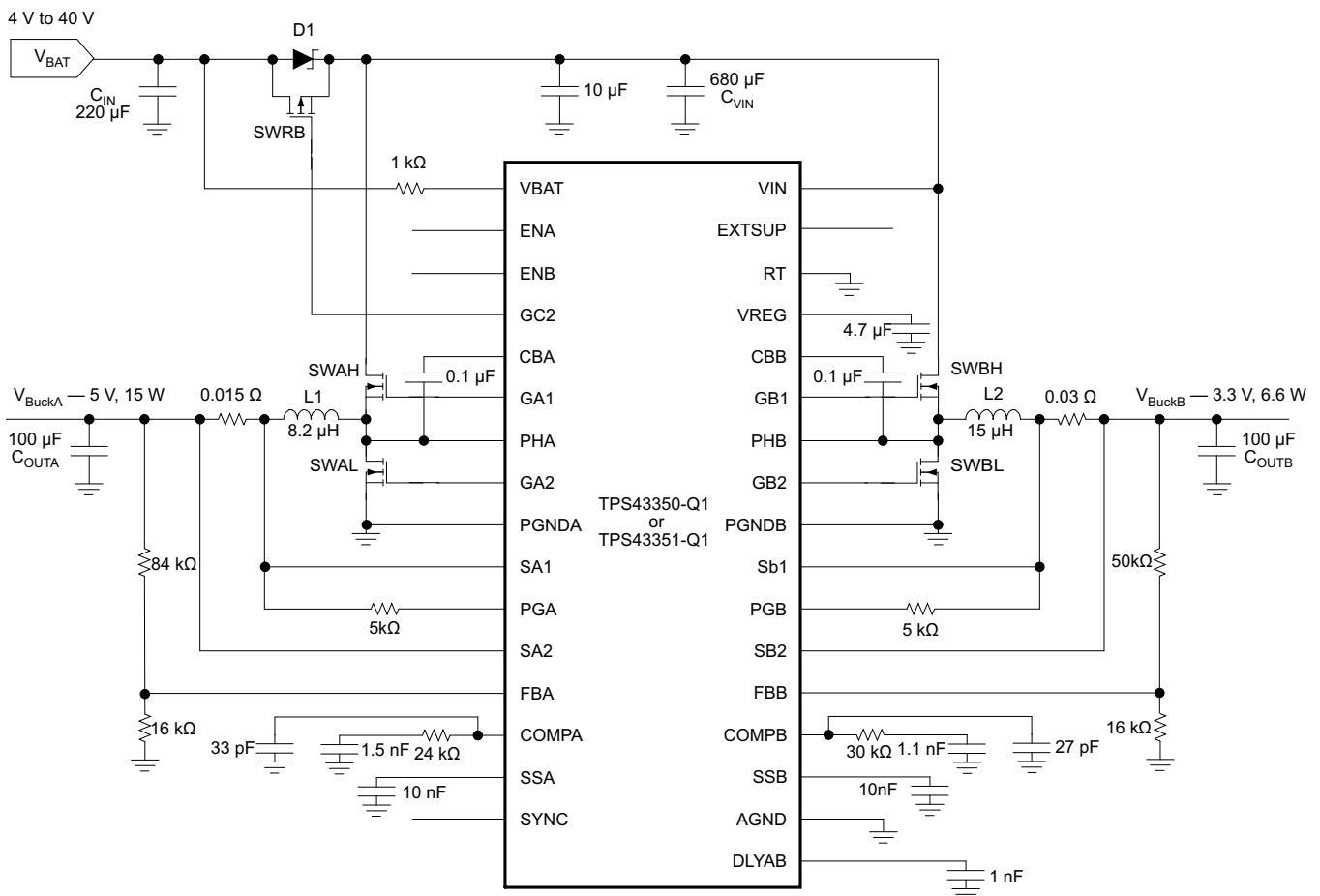
### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 8.1 Application Information

The TPS4335x-Q1 devices are dual synchronous buck controllers used to convert a higher-input voltage to two lower-output voltages. The following sections have the component values and calculations that are a good starting point for use in the application. Some of the values in the equations are theoretical values, to improve the performance of the device may require further optimization of these values.

### 8.2 Typical Application



Copyright © 2016, Texas Instruments Incorporated

Figure 14. Simplified Application Schematic Example

## Typical Application (continued)

### 8.2.1 Design Requirements

Table 3 lists the design-goal parameters.

**Table 3. Design Parameters**

PARAMETER	V <sub>BuckA</sub>	V <sub>BuckB</sub>
Input voltage	V <sub>IN</sub> = 6 V to 30 V 12 V - typical	V <sub>IN</sub> = 6 V to 30 V 12 V - typical
Output voltage, V <sub>OUTx</sub>	5 V	3.3 V
Maximum output current, I <sub>OUTx</sub>	3 A	2 A
Load step output tolerance, ΔV <sub>OUT</sub> + ΔV <sub>OUT(Ripple)</sub>	±0.2 V	±0.12 V
Current output load step, ΔI <sub>OUTx</sub>	0.1 A to 3 A	0.1 A to 2 A
Converter switching frequency, f <sub>SW</sub>	400 kHz	400 kHz

### 8.2.2 Detailed Design Procedure

The following example illustrates the design process and component selection for the TPS43350-Q1.

This is a starting point, and theoretical representation of the values to be used for the application; improving the performance of the device may require further optimization of the derived components.

**Table 4. Application Example – Component Proposals**

NAME	COMPONENT PROPOSAL	VALUE
L1	MSS1278T-822ML (Coilcraft)	8.2 μH
L2	MSS1278T-153ML (Coilcraft)	15 μH
D1	SK103 (Micro Commercial Components)	
SWRB	IRF7416 (International Rectifier)	
SWAH, SWAL, SWBH, SWBL	Si4840DY-T1-E3 (Vishay)	
C <sub>OUTA</sub> , C <sub>OUTB</sub>	ECASD91A107M010K00 (Murata)	100 μF
C <sub>IN</sub>	EEEFK1V331P (Panasonic)	330 μF

#### 8.2.2.1 BuckA Component Selection

##### 8.2.2.1.1 Minimum ON Time, t<sub>ON min</sub>

$$t_{ON\ min} = \frac{V_{OUTA}}{V_{IN\ max} \times f_{SW}} = \frac{5\ V}{30\ V \times 400\ kHz} = 416\ ns \quad (5)$$

This is higher than the minimum on-time specified (100 ns typical). Hence, the minimum duty cycle is achievable at this frequency.

##### 8.2.2.1.2 Current-Sense Resistor R<sub>SENSE</sub>

Based on the typical characteristics for V<sub>SENSE</sub> limit with V<sub>IN</sub> versus duty cycle, the sense limit is approximately 65 mV (at V<sub>IN</sub> = 12 V and duty cycle of 5 V / 12 V = 0.416). Allowing for tolerances and ripple currents, choose V<sub>SENSE</sub> with a maximum of 50 mV.

$$R_{SENSE} = \frac{50\ mV}{3\ A} = 17\ m\Omega \quad (6)$$

Select 15 mΩ.

### 8.2.2.2 Inductor Selection L

As explained in the description of the buck controllers, for optimal slope compensation and loop response, the inductor should be chosen such that:

$$L = K_{FLR} \times \frac{R_{SENSE}}{f_{SW}} = 200 \times \frac{15 \text{ m}\Omega}{400 \text{ kHz}} = 7.5 \text{ }\mu\text{H} \quad (7)$$

$K_{FLR}$  = Coil selection constant = 200

Choose a standard value of 8.2  $\mu\text{H}$ . For the buck converter, the inductor saturation currents and core should be chosen to sustain the maximum currents.

### 8.2.2.3 Inductor Ripple Current $I_{RIPPLE}$

At nominal input voltage of 12 V, this inductor value causes a ripple current of 30% of  $I_{O \text{ max}} \approx 1 \text{ A}$ .

$$\Delta I_L = \frac{\left[ (V_{IN} - V_{OUT}) \times \left( \frac{V_{OUT}}{(V_{IN} \times f_{SW})} \right) \right]}{L}$$

where

- $V_{IN}$  = Input voltage
- $V_{OUT}$  = Output voltage
- $f_{SW}$  = Switching frequency
- L = Inductor

(8)

### 8.2.2.4 Output Capacitor $C_{OUTA}$

Select an output capacitance  $C_{OUTA}$  of 100  $\mu\text{F}$  with low ESR in the range of 10 m $\Omega$ . This gives  $\Delta V_{O(Ripple)} \approx 15 \text{ mV}$  and  $\Delta V$  drop of  $\approx 180 \text{ mV}$  during a load step, which does not trigger the power-good comparator and is within the required limits.

$$C_{OUTA} \approx \frac{2 \times \Delta I_{OUTA}}{f_{SW} \times \Delta V_{OUTA}} = \frac{2 \times 2.9 \text{ A}}{400 \text{ kHz} \times 0.2 \text{ V}} = 72.5 \text{ }\mu\text{F} \quad (9)$$

$$V_{OUTA(Ripple)} = \frac{I_{OUTA(Ripple)}}{8 \times f_{SW} \times C_{OUTA}} + I_{OUTA(Ripple)} \times ESR = \frac{1 \text{ A}}{8 \times 400 \text{ kHz} \times 100 \text{ }\mu\text{F}} + 1 \text{ A} \times 10 \text{ m}\Omega = 13.1 \text{ mV} \quad (10)$$

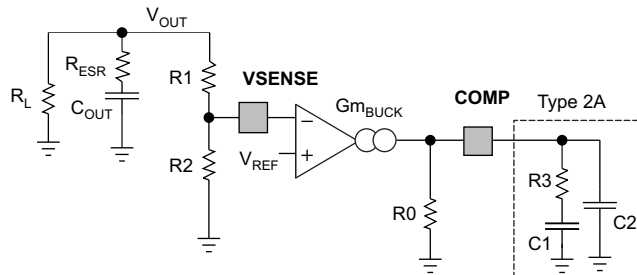
$$\Delta V_{OUTA} = \frac{\Delta I_{OUTA}}{4 \times f_C \times C_{OUTA}} + \Delta I_{OUTA} \times ESR = \frac{2.9 \text{ A}}{4 \times 50 \text{ kHz} \times 100 \text{ }\mu\text{F}} + 2.9 \text{ A} \times 10 \text{ m}\Omega = 174 \text{ mV} \quad (11)$$

### 8.2.2.5 Bandwidth of Buck Converter $f_C$

Use the following guidelines to set frequency poles, zeroes and crossover values for a tradeoff between stability and transient response.

- Crossover frequency  $f_C$  between  $f_{SW} / 6$  and  $f_{SW} / 10$ . Assume  $f_C = 50 \text{ kHz}$ .
- Select the zero  $f_z \approx f_C / 10$ .
- Make the second pole  $f_{P2} \approx f_{SW} / 2$ .

### 8.2.2.6 Selection of Components for Type II Compensation



Copyright © 2016, Texas Instruments Incorporated

**Figure 15. Buck Compensation Components**

$$R3 = \frac{2\pi \times f_c \times V_{OUT} \times C_{OUTx}}{Gm_{BUCK} \times K_{CFB} \times V_{REF}} = \frac{2\pi \times 50 \text{ kHz} \times 5 \text{ V} \times 100\mu\text{F}}{Gm_{BUCK} \times K_{CFB} \times V_{REF}} = 23.57 \text{ k}\Omega \quad (12)$$

 Use the standard value of  $R3 = 24 \text{ k}\Omega$ ,

 Where  $V_{OUT} = 5 \text{ V}$ ,  $C_{OUTx} = 100 \mu\text{F}$ ,  $Gm_{BUCK} = 1 \text{ mS}$ ,  $V_{REF} = 0.8 \text{ V}$ 
 $K_{CFB} = 0.125 / R_{SENSE} = 8.33 \text{ S}$  (0.125 is an internal constant)

$$C1 = \frac{10}{2\pi \times R3 \times f_c} = \frac{10}{2\pi \times 24 \text{ k}\Omega \times 50 \text{ kHz}} = 1.33 \text{ nF} \quad (13)$$

 Use the standard value of  $1.5 \text{ nF}$ .

$$C2 = \frac{C1}{2\pi \times R3 \times C1 \left( \frac{f_{SW}}{2} \right) - 1} = \frac{1.5 \text{ nF}}{2\pi \times 24 \text{ k}\Omega \times 1.5 \text{ nF} \left( \frac{400 \text{ kHz}}{2} \right) - 1} = 33 \text{ pF} \quad (14)$$

**The resulting bandwidth of buck converter,  $f_c$ :**

$$f_c = \frac{Gm_{BUCK} \times R3 \times K_{CFB}}{2\pi \times C_{OUTx}} \times \frac{V_{REF}}{V_{OUT}}$$

$$f_c = \frac{1 \text{ mS} \times 24 \text{ k}\Omega \times 8.33 \text{ S} \times 0.8 \text{ V}}{2\pi \times 100 \mu\text{F} \times 5 \text{ V}} = 50.9 \text{ kHz} \quad (15)$$

 This is close to the target bandwidth of  $50 \text{ kHz}$ .

**The resulting zero frequency  $f_{z1}$ :**

$$f_{z1} = \frac{1}{2\pi \times R3 \times C1} = \frac{1}{2\pi \times 24 \text{ k}\Omega \times 1.5 \text{ nF}} = 4.42 \text{ kHz} \quad (16)$$

 This is close to the  $f_c / 10$  guideline of  $5 \text{ kHz}$ .

**The second pole frequency  $f_{p2}$ :**

$$f_{p2} = \frac{1}{2\pi \times R3 \times C2} = \frac{1}{2\pi \times 24 \text{ k}\Omega \times 33 \text{ pF}} = 201 \text{ kHz} \quad (17)$$

 This is close to the  $f_{SW} / 2$  guideline of  $200 \text{ kHz}$ . Hence, the design satisfies all requirements for a good loop.

### 8.2.2.7 Resistor Divider Selection for Setting $V_{OUTA}$ Voltage

$$\beta = \frac{V_{REF}}{V_{OUTA}} = \frac{0.8 \text{ V}}{5 \text{ V}} = 0.16 \quad (18)$$

 Choose the divider current through  $R1$  and  $R2$  to be  $50 \mu\text{A}$ . Then



$$R1 + R2 = \frac{5 \text{ V}}{50 \text{ } \mu\text{A}} = 66 \text{ k}\Omega \quad (19)$$

and

$$\frac{R2}{R1 + R2} = 0.16 \quad (20)$$

Therefore, R2 = 16 kΩ and R1 = 84 kΩ.

### 8.2.2.8 BuckB Component Selection

Using the same method as for  $V_{\text{BuckA}}$  produces the following parameters and components.

$$t_{\text{ONmin}} = \frac{V_{\text{OUTB}}}{V_{\text{INmax}} \times f_{\text{SW}}} = \frac{5 \text{ V}}{30 \text{ V} \times 400 \text{ kHz}} = 416 \text{ ns} \quad (21)$$

This is higher than the minimum duty cycle specified (100 ns typical).

$$R_{\text{SENSE}} = \frac{60 \text{ mV}}{2 \text{ A}} = 30 \text{ m}\Omega$$

$$L = 200 \times \frac{30 \text{ m}\Omega}{400 \text{ kHz}} = 15 \text{ } \mu\text{H} \quad (22)$$

$\Delta I_{\text{ripple}}$  current  $\approx 0.4 \text{ A}$  (approximately 20% of  $I_{\text{OUT max}}$ )

Select an output capacitance  $C_O$  of 100 μF with low ESR in the range of 10 mΩ. Assume  $f_C = 50 \text{ kHz}$ .

$$C_{\text{OUTB}} \approx \frac{2 \times \Delta I_{\text{OUTB}}}{f_{\text{SW}} \times \Delta V_{\text{OUTB}}} = \frac{2 \times 1.9 \text{ A}}{400 \text{ kHz} \times 0.12 \text{ V}} = 46 \text{ } \mu\text{F} \quad (23)$$

$$V_{\text{OUTB(Ripple)}} = \frac{I_{\text{OUTB(Ripple)}}}{8 \times f_{\text{SW}} \times C_{\text{OUTB}}} + I_{\text{OUTB(Ripple)}} \times \text{ESR} = \frac{0.4 \text{ A}}{8 \times 400 \text{ kHz} \times 100 \text{ } \mu\text{F}} + 0.4 \text{ A} \times 10 \text{ m}\Omega = 5.3 \text{ mV} \quad (24)$$

$$\Delta V_{\text{OUTB}} = \frac{\Delta I_{\text{OUTB}}}{4 \times f_C \times C_{\text{OUTB}}} + \Delta I_{\text{OUTB}} \times \text{ESR} = \frac{1.9 \text{ A}}{4 \times 50 \text{ kHz} \times 100 \text{ } \mu\text{F}} + 1.9 \text{ A} \times 10 \text{ m}\Omega = 114 \text{ mV} \quad (25)$$

$$R3 = \frac{2\pi \times f_C \times V_{\text{OUTB}} \times C_{\text{OUTB}}}{G_{\text{mBUCK}} \times K_{\text{CFB}} \times V_{\text{REF}}} \\ = \frac{2\pi \times 50 \text{ kHz} \times 3.3 \text{ V} \times 100 \text{ } \mu\text{F}}{1 \text{ mS} \times 4.16 \text{ S} \times 0.8 \text{ V}} = 31 \text{ k}\Omega \quad (26)$$

Use the standard value of R3 = 30 kΩ.

$$C1 = \frac{10}{2\pi \times R3 \times f_C} = \frac{10}{2\pi \times 30 \text{ k}\Omega \times 50 \text{ kHz}} = 1.1 \text{ nF} \quad (27)$$

$$C2 = \frac{C1}{2\pi \times R3 \times C1 \times \left(\frac{f_{\text{SW}}}{2}\right) - 1} \\ = \frac{1.1 \text{ nF}}{2\pi \times 30 \text{ k}\Omega \times 1.1 \text{ nF} \times \left(\frac{400 \text{ kHz}}{2}\right) - 1} = 27 \text{ pF} \quad (28)$$

$$f_c = \frac{Gm_{BUCK} \times R3 \times K_{CFB} \times V_{REF}}{2\pi \times C_{OUTB}} \times \frac{V_{REF}}{V_{OUTB}}$$

$$= \frac{1 \text{ mS} \times 30 \text{ k}\Omega \times 4.16 \text{ S} \times 0.8 \text{ V}}{2\pi \times 100 \text{ }\mu\text{F} \times 3.3 \text{ V}} = 48 \text{ kHz} \quad (29)$$

This is close to the target bandwidth of 50 kHz.

**The resulting zero frequency  $f_{z1}$ :**

$$f_{z1} = \frac{1}{2\pi \times R3 \times C1} = \frac{1}{2\pi \times 30 \text{ k}\Omega \times 1.1 \text{ nF}} = 4.8 \text{ kHz} \quad (30)$$

This is close to the  $f_c$  guideline of 5 kHz.

**The second pole frequency  $f_{p2}$ :**

$$f_{p2} = \frac{1}{2\pi \times R3 \times C2} = \frac{1}{2\pi \times 30 \text{ k}\Omega \times 27 \text{ pF}} = 196 \text{ kHz} \quad (31)$$

This is close to the  $f_{SW} / 2$  guideline of 200 kHz.

Hence, the design satisfies all requirements for a good loop.

### 8.2.2.9 Resistor Divider Selection for Setting $V_{OUT}$ Voltage

$$\beta = \frac{V_{REF}}{V_{OUT}} = \frac{0.8 \text{ V}}{3.3 \text{ V}} = 0.242 \quad (32)$$

Choose the divider current through R1 and R2 to be 50  $\mu\text{A}$ . Then

$$R1 + R2 = \frac{3.3 \text{ V}}{50 \text{ }\mu\text{A}} = 66 \text{ k}\Omega \quad (33)$$

and

$$\frac{R2}{R1 + R2} = 0.242 \quad (34)$$

Therefore,  $R2 = 16 \text{ k}\Omega$  and  $R1 = 50 \text{ k}\Omega$ .

### 8.2.2.10 BUCKx High-Side and Low-Side N-Channel MOSFETs

An internal supply, which is 5.8 V typical under normal operating conditions, provides the gate-drive supply for these MOSFETs. The output is a totem pole allowing full voltage drive of  $V_{REG}$  to the gate with peak output current of 1.5 A. The reference for the high-side MOSFET is a floating node at the phase terminal (PHx), and the reference for the low-side MOSFET is the power-ground (PGx) terminal. For a particular application, select these MOSFETs with consideration for the following parameters:  $r_{DS(on)}$ , gate charge  $Q_g$ , drain-to-source breakdown voltage  $BVDSS$ , maximum dc current  $IDC(max)$ , and thermal resistance for the package.

The times  $t_r$  and  $t_f$  denote the rising and falling times of the switching node and have a relationship to the gate-driver strength of the TPS43350x-Q1 and gate Miller capacitance of the MOSFET. The first term denotes the conduction losses, which are minimal when the on-resistance of the MOSFET is low. The second term denotes the transition losses, which arise due to the full application of the input voltage across the drain-source of the MOSFET as it turns on or off. They are lower at low currents and when the switching time is low.

$$P_{BuckTOPFET} = (I_{OUT})^2 \times r_{DS(on)}(1 + TC) \times D + \left( \frac{V_{IN} \times I_{OUT}}{2} \right) \times (t_r + t_f) \times f_{SW} \quad (35)$$

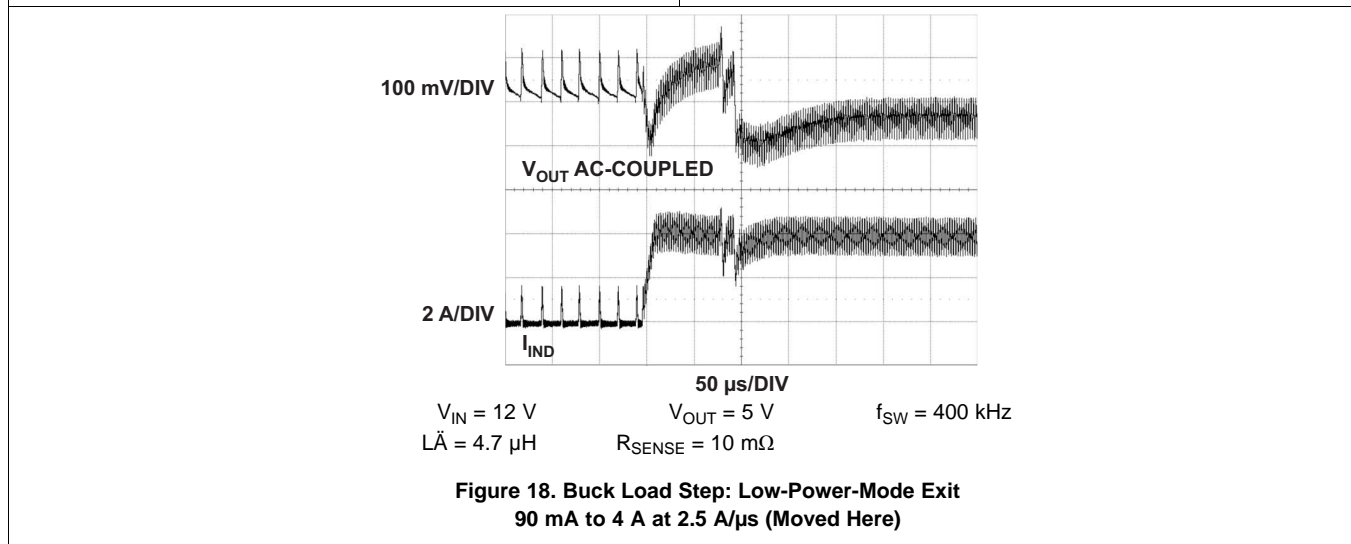
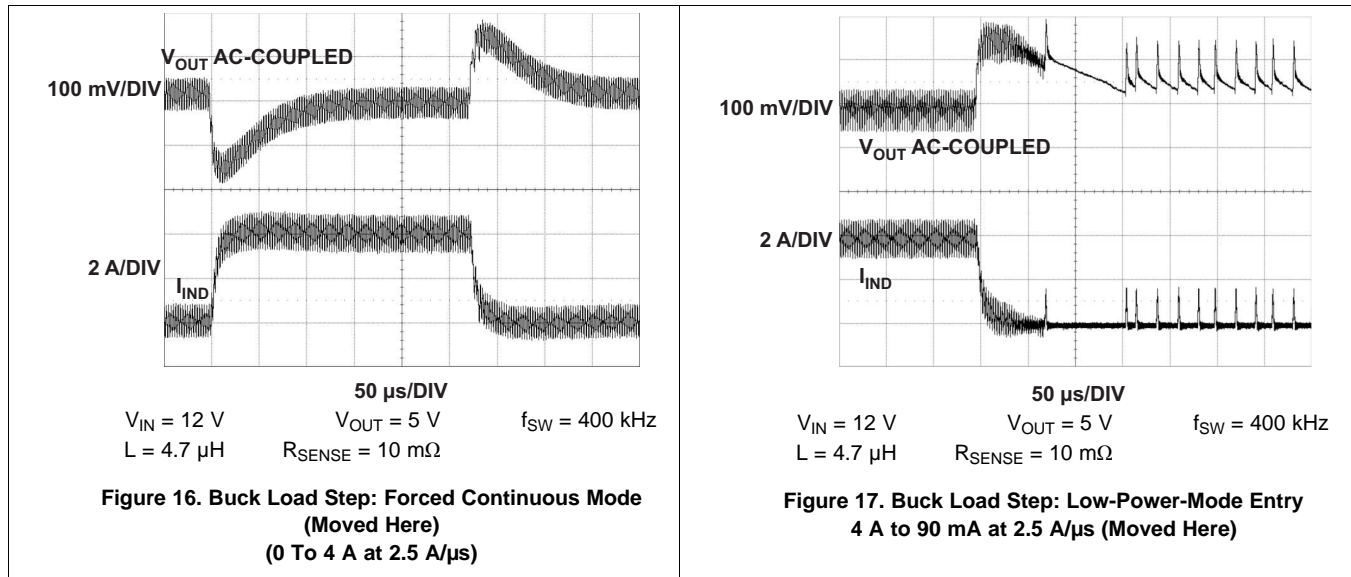
$$P_{BuckLOWERFET} = (I_{OUT})^2 \times r_{DS(on)}(1 + TC) \times (1 - D) + V_F \times I_{OUT} \times (2 \times t_d) \times f_{SW} \quad (36)$$

In addition, during dead time  $t_d$  when both the MOSFETs are off, the body diode of the low-side MOSFET conducts, increasing the losses. The second term in the foregoing equation denotes this. Using external Schottky diodes in parallel to the low-side MOSFETs of the buck converters helps to reduce this loss.

**NOTE**

The  $r_{DS(on)}$  has a positive temperature coefficient, and TC term for  $r_{DS(on)}$  accounts for that fact.  $TC = d \times \Delta T [^{\circ}C]$ . The temperature coefficient  $d$  is available as a normalized value from MOSFET data sheets and can be assumed to be  $0.005 / ^{\circ}C$  as a starting value.

**8.2.3 Application Curves**



**9 Power Supply Recommendations**

The TPS4335x-Q1 devices operate over an input voltage supply range between 4 V and 40 V. This input must be well regulated, and if the power source is located more than a few inches from the TPS4335x-Q1 devices, bulk capacitance and bypass capacitors may be required at the power supply input.

## 10 Layout

### 10.1 Layout Guidelines

This section lists the grounding and PCB circuit layout considerations.

#### 10.1.1 Buck Converter

1. Connect the drain of SWAH and SWBH MOSFETs together with the positive terminal of the input capacitor  $C_{IN}$ . The trace length between these terminals should be short.
2. Connect a local decoupling capacitor between the drain of SWxH and source of SWxL.
3. The Kelvin-current sensing for the shunt resistor should have traces with minimum spacing, routed in parallel with each other. Place any filtering capacitors for noise near the IC pins.
4. The resistor divider for sensing output voltage connects between the positive terminal of the respective output capacitor and  $C_{OUTA}$  or  $C_{OUTB}$  and the IC signal ground. Do not locate these components and their traces near any switching nodes or high-current traces.

#### 10.1.2 Other Considerations

1. Short PGNDx and AGND to the thermal pad. Use a star ground configuration if there is no ground plane present in the system. Use tie-ins for the EXTSUP capacitor, compensation-network ground, and voltage-sense feedback-ground networks to this star ground.
2. Connect a compensation network between the compensation pins and IC signal ground. Connect the oscillator resistor (frequency setting) between the RT pin and IC signal ground. Do not locate these sensitive circuits near the dv/dt nodes; these include the gate-drive outputs and phase pins.
3. Reduce the surface area of the high-current-carrying loops to a minimum by ensuring optimal component placement. Ensure the bypass capacitors are located as close as possible to their respective power and ground pins.

### 10.2 Layout Example

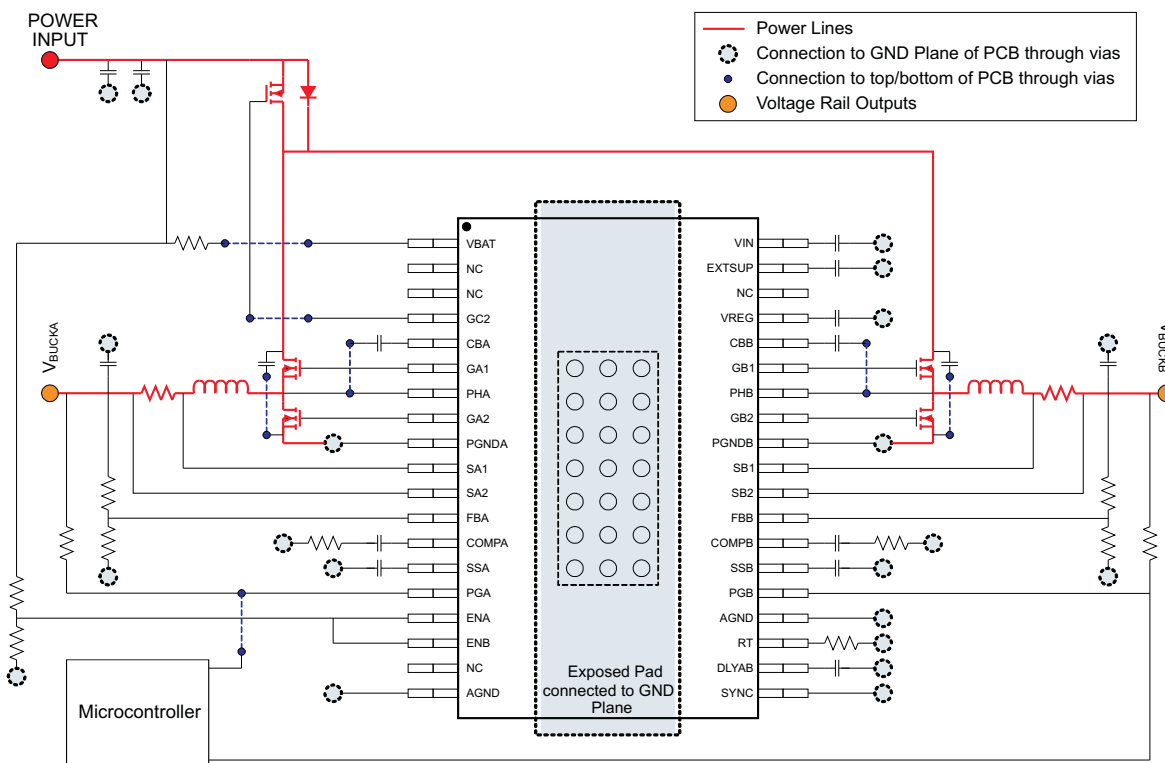


Figure 19. TPS4335x-Q1 Layout Example

## 11 Device and Documentation Support

### 11.1 Device Support

#### 11.1.1 Third-Party Products Disclaimer

TI'S PUBLICATION OF INFORMATION REGARDING THIRD-PARTY PRODUCTS OR SERVICES DOES NOT CONSTITUTE AN ENDORSEMENT REGARDING THE SUITABILITY OF SUCH PRODUCTS OR SERVICES OR A WARRANTY, REPRESENTATION OR ENDORSEMENT OF SUCH PRODUCTS OR SERVICES, EITHER ALONE OR IN COMBINATION WITH ANY TI PRODUCT OR SERVICE.

### 11.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

**Table 5. Related Links**

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
TPS43350-Q1	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>
TPS43351-Q1	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>

### 11.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 11.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](http://e2e.ti.com), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 11.5 Trademarks

PowerPAD, E2E are trademarks of Texas Instruments.  
All other trademarks are the property of their respective owners.

### 11.6 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 11.7 Glossary

**SLYZ022** — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS43350QDAPRQ1	ACTIVE	HTSSOP	DAP	38	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 125	TPS43350Q1	<a href="#">Samples</a>
TPS43351QDAPRQ1	ACTIVE	HTSSOP	DAP	38	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 125	TPS43351Q1	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS43350QDAPRQ1	HTSSOP	DAP	38	2000	330.0	24.4	8.6	13.0	1.8	12.0	24.0	Q1
TPS43351QDAPRQ1	HTSSOP	DAP	38	2000	330.0	24.4	8.6	13.0	1.8	12.0	24.0	Q1

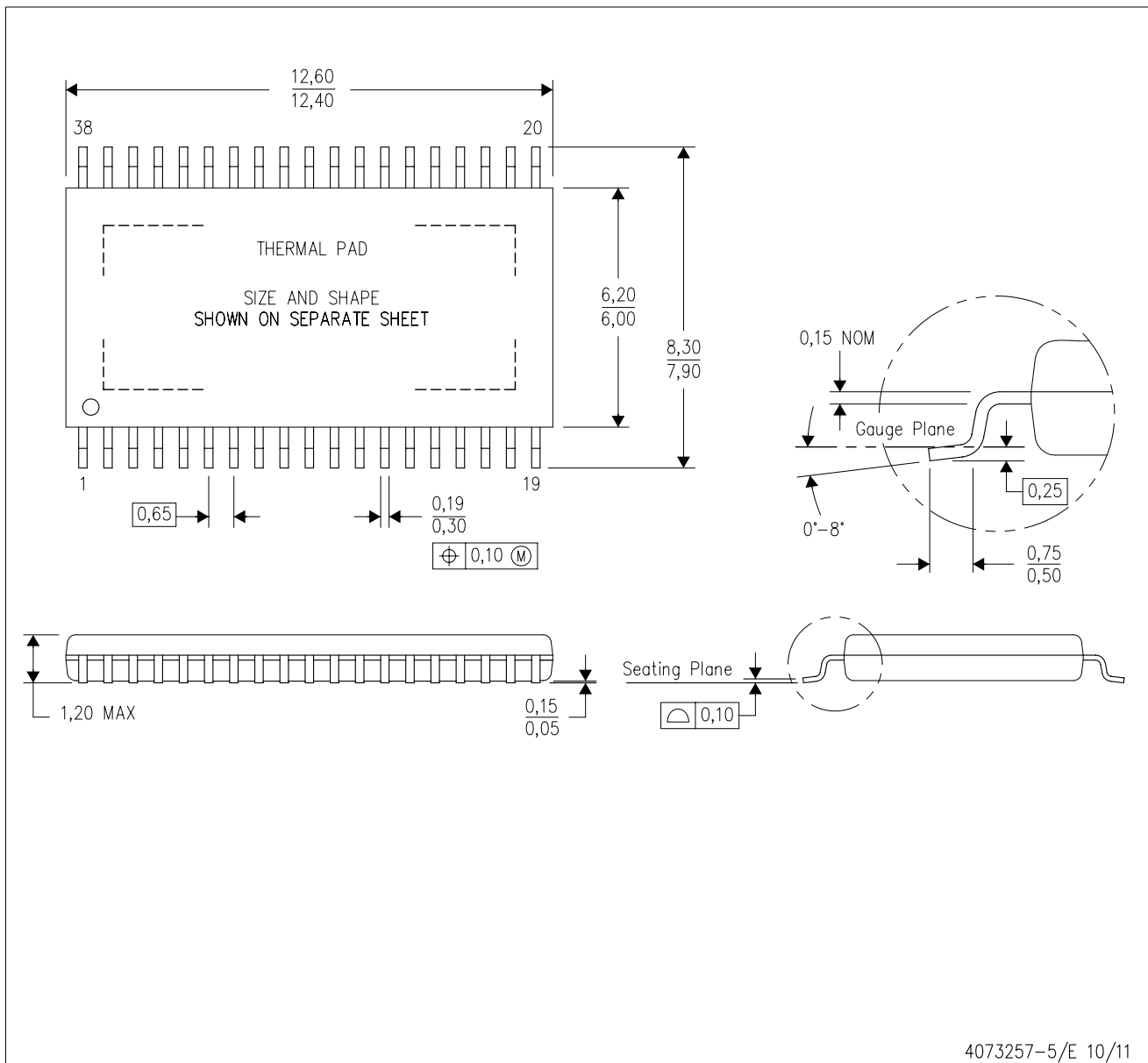
**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS43350QDAPRQ1	HTSSOP	DAP	38	2000	367.0	367.0	45.0
TPS43351QDAPRQ1	HTSSOP	DAP	38	2000	367.0	367.0	45.0

# MECHANICAL DATA

DAP (R-PDSO-G38) PowerPAD™ PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
  - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- ⚠ Falls within JEDEC MO-153 Variation DDT-1.

PowerPAD is a trademark of Texas Instruments.

# THERMAL PAD MECHANICAL DATA

DAP (R-PDSO-G38)

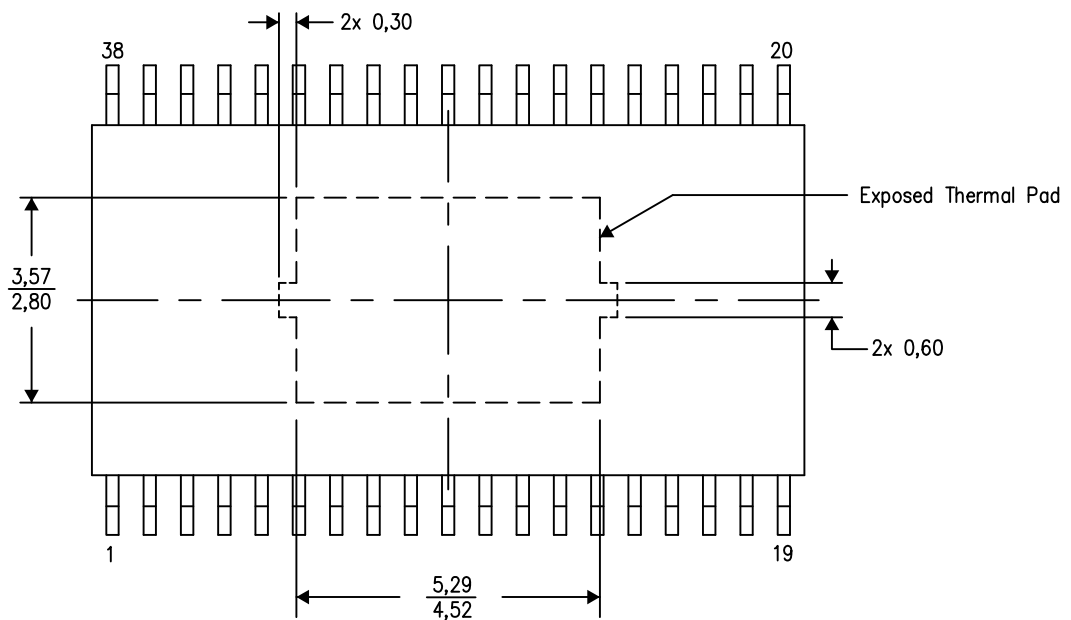
PowerPAD™ PLASTIC SMALL OUTLINE

## THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



Top View  
Exposed Thermal Pad Dimensions

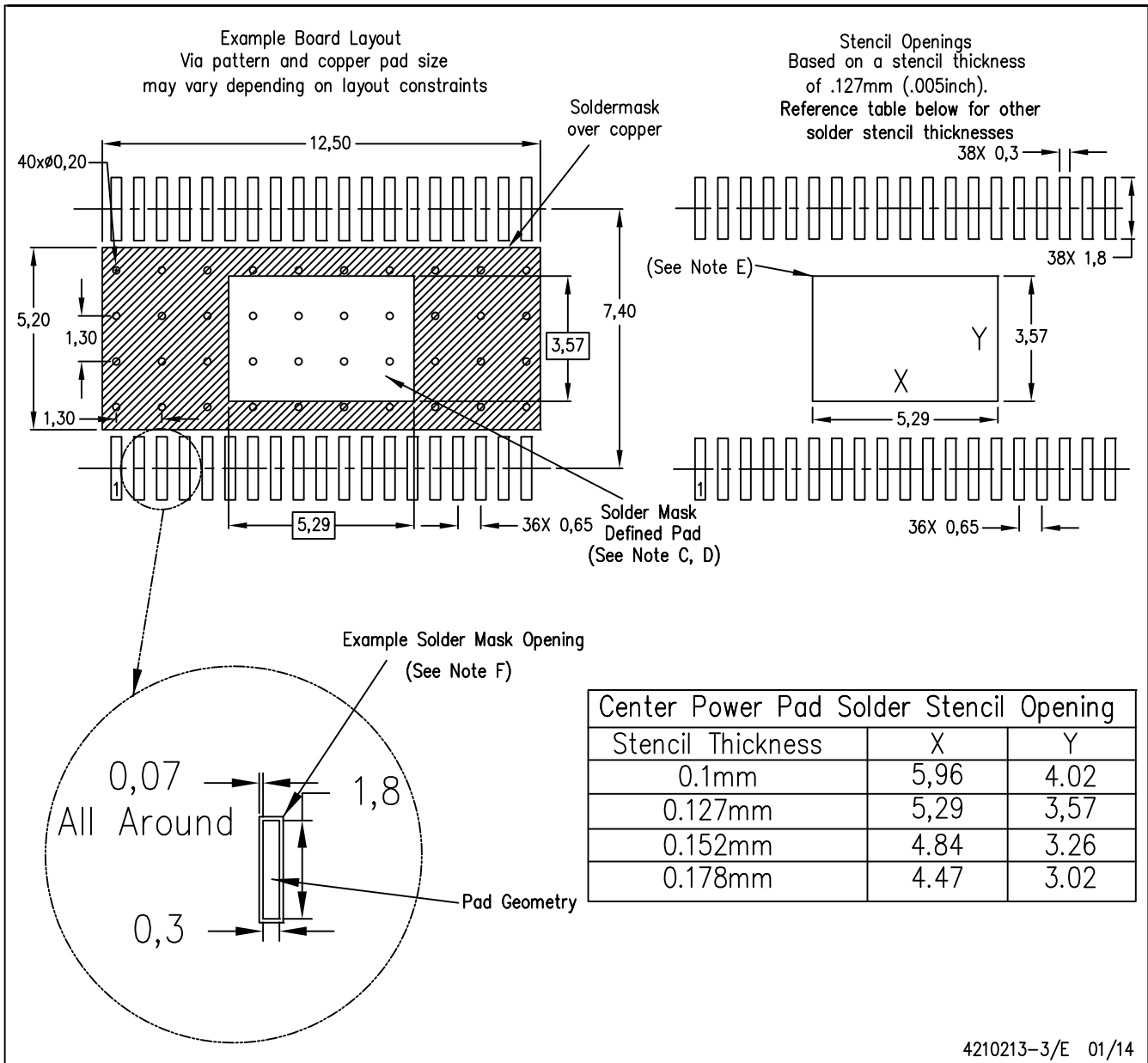
4206319-9/M 09/13

NOTE: All linear dimensions are in millimeters

PowerPAD is a trademark of Texas Instruments.

# LAND PATTERN DATA

## DAP (R-PDSO-G38) PowerPAD™ PLASTIC SMALL OUTLINE PACKAGE



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
  - This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>. Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - Contact the board fabrication site for recommended soldermask tolerances.

PowerPAD is a trademark of Texas Instruments

## IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

### Products

Audio	<a href="http://www.ti.com/audio">www.ti.com/audio</a>
Amplifiers	<a href="http://amplifier.ti.com">amplifier.ti.com</a>
Data Converters	<a href="http://dataconverter.ti.com">dataconverter.ti.com</a>
DLP® Products	<a href="http://www.dlp.com">www.dlp.com</a>
DSP	<a href="http://dsp.ti.com">dsp.ti.com</a>
Clocks and Timers	<a href="http://www.ti.com/clocks">www.ti.com/clocks</a>
Interface	<a href="http://interface.ti.com">interface.ti.com</a>
Logic	<a href="http://logic.ti.com">logic.ti.com</a>
Power Mgmt	<a href="http://power.ti.com">power.ti.com</a>
Microcontrollers	<a href="http://microcontroller.ti.com">microcontroller.ti.com</a>
RFID	<a href="http://www.ti-rfid.com">www.ti-rfid.com</a>
OMAP Applications Processors	<a href="http://www.ti.com/omap">www.ti.com/omap</a>
Wireless Connectivity	<a href="http://www.ti.com/wirelessconnectivity">www.ti.com/wirelessconnectivity</a>

### Applications

Automotive and Transportation	<a href="http://www.ti.com/automotive">www.ti.com/automotive</a>
Communications and Telecom	<a href="http://www.ti.com/communications">www.ti.com/communications</a>
Computers and Peripherals	<a href="http://www.ti.com/computers">www.ti.com/computers</a>
Consumer Electronics	<a href="http://www.ti.com/consumer-apps">www.ti.com/consumer-apps</a>
Energy and Lighting	<a href="http://www.ti.com/energy">www.ti.com/energy</a>
Industrial	<a href="http://www.ti.com/industrial">www.ti.com/industrial</a>
Medical	<a href="http://www.ti.com/medical">www.ti.com/medical</a>
Security	<a href="http://www.ti.com/security">www.ti.com/security</a>
Space, Avionics and Defense	<a href="http://www.ti.com/space-avionics-defense">www.ti.com/space-avionics-defense</a>
Video and Imaging	<a href="http://www.ti.com/video">www.ti.com/video</a>

### TI E2E Community

[e2e.ti.com](http://e2e.ti.com)